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### Title

Hybrid System Combining Two-Dimensional Materials and Ferroelectrics and Its Application in Photodetection

### Permalink

<https://escholarship.org/uc/item/3b73x21z>

### Journal

ACS Nano, 15(7)

### ISSN

1936-0851

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### Publication Date

2021-07-27

### DOI

10.1021/acsnano.1c01735

Peer reviewed

1 DOI: 10.1002/ ((please add manuscript number))

2 **Article type: Review**

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5 Photodetectors Based on Hybrid Systems Combining Two-dimensional materials and  
6 Ferroelectrics

7

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25 **Keywords:** two-dimensional materials; ferroelectrics; photodetectors; hybrid systems

26

27 Two-dimensional materials have been extensively studied in last decades due to their  
28 remarkable physical, electrical and optoelectronic properties. Meanwhile, combination of  
29 two-dimensional materials with traditional functional materials have provided new approach  
30 in a variety of research and application areas. In this review, we have focused on the two-  
31 dimensional and ferroelectric hybrid system being applied in photodetection. Fundamentals of  
32 the materials and interaction in the hybrid system was introduced. Modulation of the  
33 optoelectronic properties induced by ferroelectricity was discussed in the hybrid system. After  
34 introducing the basics of photodetection, the devices were categorized and reviewed based on  
35 their structures. Modulation and enhancement of the photodetectors were observed with  
36 ferroelectric polarization. Finally, the challenges and perspectives of the photodetectors based  
37 on two-dimensional materials and ferroelectrics have been proposed.

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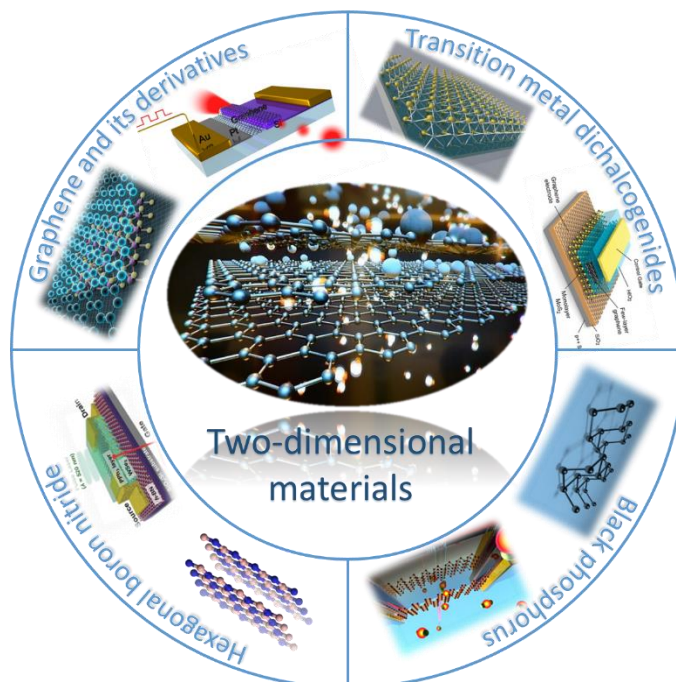
## 39 **1. Introduction**

40 Last decades have witnessed rapid development of photonic and optoelectronic devices which  
41 demonstrate a wide spectrum of applications including photo-emission (eg. photodiodes[1, 2,  
42 3, 4], LEDs[5, 6] and lasers[7, 8]), photodetection[9, 10, 11, 12, 13], data storage[14, 15] and  
43 energy storage[16, 17]. Nowadays, the information society featuring “Internet of Things” and  
44 “big data” demands further evolution of electronics and optoelectronics, particularly for  
45 telecommunication and communication. Photodetectors, serving as the receiving end, are one  
46 of the most important components in such optic communication network. [18] Photodetectors  
47 are among the most ubiquitous devices with superiorities of the sufficiently fast response, the  
48 high detectivity, the remarkable data storage capability etc. Photodetectors detect light in a  
49 certain range of frequency band and the device performance can be evaluated by a series of  
50 figures of merit, which are dominated by the device structure and more importantly by  
51 detecting materials. Among the massive materials and devices applied in the photodetection,  
52 semiconductor-based photodetectors have attracted intense interest from both academic and

53 industrial fields, thanks to their smaller size, wide band detection and Si-technology  
54 compatibility. These photodetectors could be tailored by simply altering the composition of  
55 the various layers forming the structure. Both individual devices and the component in the  
56 communication system requires compact structure, ultra-thin devices and further optimization  
57 of the opto-electronic properties, which has triggered the flourishing of novel materials with  
58 outstanding structure and properties.

59 Conventional materials applied in electronic and optoelectronic semiconductor devices are  
60 crystalline silicon (Si) and germanium (Ge). Compounds of III-V semiconductors such as  
61 Gallium (Ga), Indium (In), Arsenic (As), Phosphorus (P) and antimony (Sb) are also applied  
62 in the materials as well as the alloys due to their direct bandgap property and have been  
63 intensively studied for years.[19, 20, 21] More recently, with the advent of two-dimensional  
64 (2D) materials,[22, 23] various new photodetection phenomenon have been reported due to  
65 their mechanical, thermal, electrical, optical and optoelectronic properties distinguished from  
66 that of the three-dimensional counterparts, [24, 25, 26] which has made a tremendous  
67 progress of photodetectors. Materials with Van der Waals bonds interlayers usually form thick  
68 bulk or crystals which makes them difficult utilized in nanodevices. Such obstacle was  
69 overcome by the Novoselov and Geim in 2004, who successfully exfoliated the graphene  
70 nano flake and applied it in a field-effect transistor (FET) for ultrafast photodetection.[27, 28]  
71 Since then, 2D materials have rapidly been established as building blocks for photodetectors  
72 due to their remarkable optical and optoelectronic properties.[29, 30, 31] Fabrication  
73 procedure of 2D materials photodetectors is quite simple, which as well provides a facile  
74 platform for micro- and nano- devices fabrication.[32, 33] In general, 2D materials are  
75 potential in building highly integrated and efficient photodetectors, and promising candidate  
76 for the future integrated optoelectronic devices as well.

77 The library of 2D materials has experienced a gradual expansion from graphene to its  
78 derivatives (eg. graphene, carbon nano tubes (CNTs), hexagonal boron nitride (h-BN), and to



79

80 **Figure 1.** Categories of 2D materials and their applications in electronics and optoelectronics.

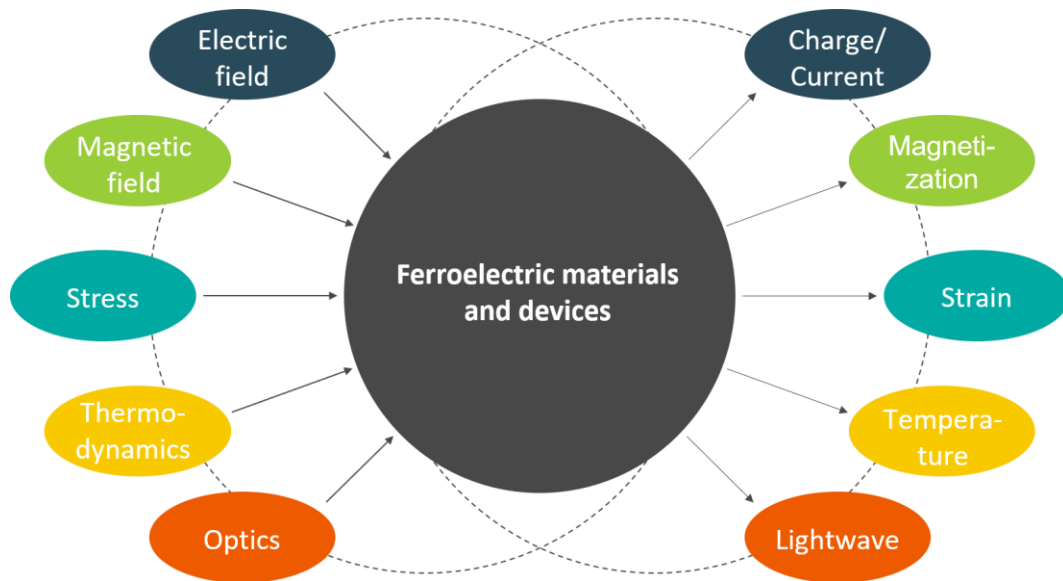
81 [34, 35, 36] Copyright Year, Publisher.

82 layered group-IV and group-III metal chalcogenides, as well as to layered transition metal  
 83 dichalcogenides (TMDs) with their alloys and heterostructures and other novel functional  
 84 materials etc., as summarized in [Figure 1](#). [34, 35, 36] With the growth of 2D materials family,  
 85 they have covered from metal, semiconductor to insulators now. 2D materials have ultra-thin  
 86 physical structure ranging from  $\sim 0.4$  nm (one monolayer) to bulk materials with tens of  
 87 nanometers. Some 2D materials, like graphene and TMDs, show a typical bandgap transition  
 88 with the thickness variation, which provide opportunities for bandgap modulation. [37]  
 89 Meanwhile, Electrical and optoelectronic properties of the 2D materials are closely related to  
 90 the band structure, which corresponding to the thickness variation and bandgap modulation in  
 91 2D materials. [38] Furthermore, The atomic-scale thickness of 2D materials leads to the high  
 92 transparency and flexibility, which is of particular interest in novel wearable, flexible and  
 93 portable devices.

94 Meanwhile, another category of materials being employed in electronic and optoelectronic  
95 devices are functional materials, also known as “smart materials”, with typical properties  
96 responding to the external stimuli. [39] Functional materials are capable of coupling the input  
97 (eg. electric field, magnetic field, stress, light field and heat) and output (eg. charge/current,  
98 magnetization, strain, light and temperature), as shown in [Figure 2](#). [40] The “smart materials”  
99 nowadays are widely applied in actuators, sensors and detectors. Among smart materials,  
100 ferroelectrics is unique due to its spontaneous reversal of polarization with switching of  
101 external electric field. Main application areas of ferroelectrics include energy harvesting,  
102 memory devices and data storage devices. [41, 42, 43, 44]. More and more electronic devices  
103 and photodetectors with profound performances are achieved with ferroelectric materials  
104 employed. [45]

105 Photodetection could be realized with ferroelectrics as active layers, where polarization of the  
106 materials could be altered by the incident light, resulted in linear, nonlinear optical or  
107 electrical output. Furthermore, polarization of the ferroelectrics enables wavelengths  
108 modulation by altering of the applied polarization direction. Both inorganic ferroelectric  
109 materials like  $\text{Pb}(\text{Zr},\text{Ti})\text{O}_3$  (PZT), [46, 47, 48, 49]  $\text{BaTiO}_3$  (BTO), [50, 51]  $\text{LiNbO}_3$  (LN), [52,  
110 53]  $\text{BiFeO}_3$  (BFO) [54, 55, 56] and organic compounds PVDF as well as the derivatives [57,  
111 58] have been studied and applied in photodetectors. Nevertheless, ferroelectrics can only  
112 response to limited frequency band width of light, for other incident light to which  
113 ferroelectrics are unable to response, other group of the materials could be introduced. 2D  
114 materials, which are known for their wide band response could combine with ferroelectric  
115 layers. Such hybrid photodetection systems might probably lead to new phenomena and  
116 therefore become a topic attracting increasing studies. As for the photodetectors, the hybrid  
117 structure could modulate the carriers and performance of the devices could be optimized.

118 In addition to the materials chosen in photodetection, structure of the devices is also of vital  
119 importance. Grouped by structures, photodetectors include devices like phototubes,



120

121 **Figure 2.** Coupling of the fields in ferroelectric materials and devices

122 photomultipliers and semiconductor photodetectors. Phototubes and photomultipliers are  
 123 mostly applied as dependent devices. As for the semiconductor photodetectors, one of the  
 124 most prominent advantages is its capability of been compacted into integrated circuits.  
 125 Furthermore, photodetection arrays could thus been achieved. Basic structures of the  
 126 semiconductor photodetectors could be categorized into PN diodes, Schottky diodes as well as  
 127 field effect transistors *etc.*.

128 In this work, we review the structures and devices based on ferroelectrics and 2D materials  
 129 hybrid system for photodetection. Fundamentals of the 2D materials and ferroelectrics  
 130 including structure, electrical, optoelectronic and interaction of the hybrid system are  
 131 presented. After that, various structures and corresponding nano devices for photodetection  
 132 are discussed in detail, including PN junctions, field effect transistors and other types of  
 133 devices. Performances of the hybrid devices was summarized and discussed. This review  
 134 outlines the important aspects of the ferroelectrics-2D materials hybrid photodetectors and is  
 135 certainly of great interest for design novel photodetectors.

## 136 **2. Fundamentals of 2D materials and ferroelectrics**

### 137 **2.1. Fundamentals of 2D materials**

138 Exfoliation of the monolayer graphene has opened the door to research 2D materials.  
139 Monolayer graphene was applied in the FET and the outstanding electrical and structure  
140 property were observed. With deep exploration of graphene and its relative derives, as well as  
141 other 2D materials with similar structure for instance the hexagonal-boron nitride (h-BN),  
142 TMDs and black phosphorus (BP). These novel 2D materials share excellent optical and  
143 optoelectronic properties, which attracting more research for optoelectronic devices.

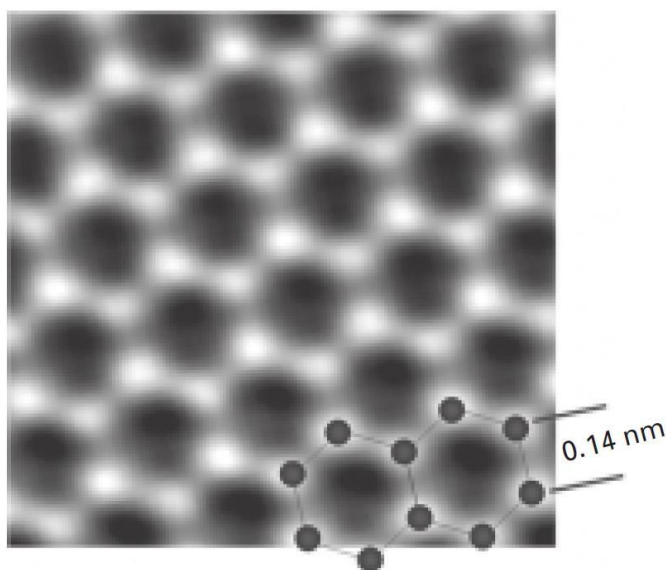
#### 144 2.1.1. Graphene

145 It was convinced that nano-materials were hardly remain stable due to thermal fluctuation,  
146 which consequently lead to decomposition of the materials. In this case, the thermally stable  
147 and chemically inert graphene has brought big surprise to scientist, leading to booming  
148 development of 2D materials research area in the past decades.[33, 59, 60] Researchers tried  
149 to add the “fresh blood” into the “old fashioned” methods, devices and systems to create  
150 novel structures and to improve the performance.

151 Graphene has in-plane chemistry bond connecting the atoms and can stack with Van der  
152 Waals forces between layers. The structure of graphene is hexagonal arrangement of  $sp^2$ -  
153 bonded carbon atoms with zero bandgap and Dirac point. In graphene, single layer of carbon  
154 atoms with  $sp^2$ -hybridization arranged in a honeycomb lattice, which is just one atom thick at  
155 vertical dimension (about 0.14 nm). Each carbon atom in-plane bonds to other three nearest  
156 atoms with a distance of 1.42 Å, shown in [Figure 3](#). [61] The lattice of graphene can be  
157 considered as two interpenetrating triangular sub-lattice A and B, see in [Figure 4\(a\)](#). Band  
158 structure in graphene materials could be modeled by the tight-binding approximation as well  
159 as calculated based on the first principle.[62, 63, 64], as shown in [Figure 4\(b\) and \(c\)](#).

160 The  $p_z$  orbitals remained, which do not involve in the covalent bonding, is responsible for the  
161 electric conductivity. Graphene is a promising candidate for electronic devices with  
162 outstanding electrical properties. Conductivity and mobility of the graphene nanosheets





163

164 **Figure 3.** Atomic structure of graphene nanosheets demonstrated the bond between the atoms  
165 and the honeycomb structure of the graphene layer (courtesy of Berkeley's TEAM05, 2009).

166 mostly depend on the defect scattering process, which is almost independent from temperature.

167 [65] The minimum conductivity of graphene theoretically exhibits at the Dirac point as

168  $4e^2/\pi h$ . The electron mobility ranges from  $\sim 0.67 \times 10^4 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$  up to  $10^6 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$  in the

169 form of suspended nanosheets or supported by  $\text{SiO}_2/\text{Si}$  substrates. [30, 66, 67] Meanwhile,

170 high current carrying capacity of  $\sim 5.8 \times 10^6 \text{ A} \cdot \text{cm}^{-2}$  and  $\sim 1.8 \times 10^9 \text{ A} \cdot \text{cm}^{-2}$  in graphene/Cu nano-

171 composite wires and on synthetic diamond substrate, respectively.[68, 69, 70] Such high

172 current carrying capacity is particularly feasible for the energy storage system and device

173 minimization. Additionally, high thermal conductivity ranging from  $\sim 4840 \text{ W/m} \cdot \text{K}$  to  $5300$

174  $\text{W/m} \cdot \text{K}$  has been observed in layered graphene nanosheets, indicating their outstanding heat

175 dissipation capability, which can be beneficial for batteries and thermal conductive devices.

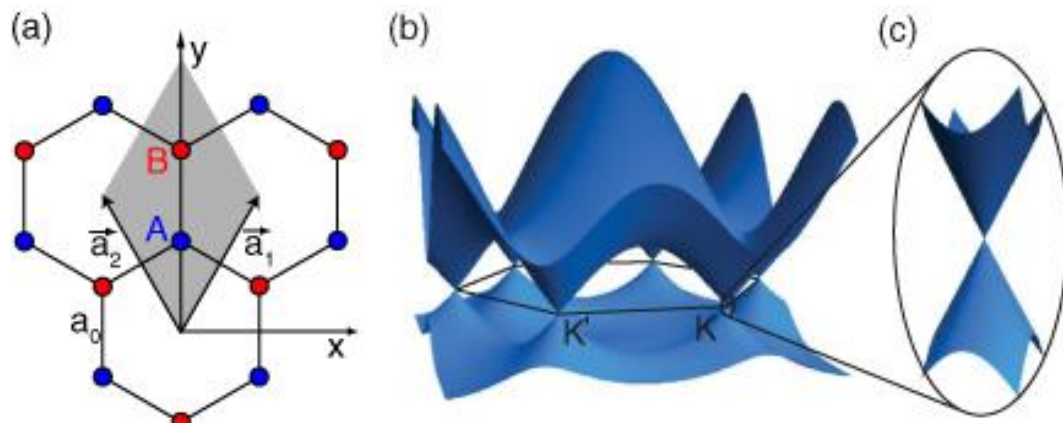
176 [71]Relative low contact resistance  $100 \text{ } \Omega \cdot \mu\text{m}$  between graphene and metal electrodes allows

177 the application of electronic devices with low Schottky barrier height.[72] Graphene is

178 different from conventional metals not only due to its 2D structure and transparency in a wide

179 band incident light but also because of its ambipolar field effect transport property. Graphene

180 is consequently known as the "semimetal".[73, 74, 75, 76, 77, 78]



181  
 182 **Figure 4.** (a) lattice, (b) band structure and (c) zero-bandgap achieved by tight-binding  
 183 approximation

184 As the zero-band gap structure, graphene should theoretically be capable of responding to all  
 185 the photons, which consequently leads to the advantage of wide band detection from  
 186 ultraviolet to infra-red and all the way to Terahertz region.[31, 79, 80] In addition to the wide  
 187 band response properties, pristine monolayer graphene is of high transparency, with  
 188 absorption of 2.3% in a wide band. [81] Such high transmittance brings the opportunity for  
 189 graphene being applied as transparent electrodes, especially for those allow large absorption  
 190 area. Moreover, broad band absorption of graphene could be modulated by shifting the  
 191 electronic Fermi level, which could consequently dominate the photon transition in graphene  
 192 nanosheets.[82, 83] With interaction of incident light, energy could be converted among  
 193 carriers, photons and phonons in graphene by transition of the charge carriers (electrons and  
 194 holes). Macroscopic phenomena such as photon absorption,[84, 85] nonlinear optical  
 195 properties[86, 87, 88], plasmons,[89, 90] and photo-current have been observed.

#### 196 2.1.2. Transition Metal Dichalcogenides

197 Another group of 2D materials with intrinsic bandgap and similar electrical properties, as well  
 198 as optoelectrical properties with graphene are TMDs. TMDs with chemical formula  $\text{MX}_2$ , is a  
 199 group of materials composed of transition metal (eg. Mo, W, etc.) and chalcogen (eg. S, Se,  
 200 Te, etc.), as shown in [Figure 5](#). TMDs share similar structures that can be categorized into

IVB	VB	VIB	VIIB	VIII			VIA
22 Ti	23 V	24 Cr	25 Mn	26 Fe	27 Co	28 Ni	16 S
40 Zr	41 Nb	42 Mo	43 Tc	44 Ru	45 Rh	46 Pd	34 Se
72 Hf	73 Ta	74 W	75 Re	76 Os	77 Ir	78 Pt	52 Te

201

202 **Figure 5.** Elements for TMDs. The ones marked in orange means only some of the

203 compounds can form int layered structures

204 several polytypes varying in stacking orders and metal atom coordination, as shown in [Figure](#)

205 [6](#).<sup>[91]</sup> The 2H, 3R and 1T phases are the most stable and common structure of TMDs, among

206 which 1H is the most stable and the most studied structure. 3R and 1T phase are metastable

207 and can be converted into 2H by annealing, heating or laser excitation. <sup>[92, 93]</sup> Properties of

208 different compounds varies at conductivity. For example, compounds with M=Mo and W,

209 X=Se and S are semiconducting,<sup>[94, 95, 96]</sup> while with M=Nb and Ta are metallic.<sup>[97]</sup>

210 TMDs experience the transition of indirect bandgap to direct optical bandgap with the number

211 of layers decreased to bilayer or monolayer, as shown in [Figure 7](#).<sup>[98]</sup> The bandgap ranges

212 from 1.0 eV to 2.1 eV, see in [Table 1](#). Some of the TMDs, like TiS<sub>2</sub> and WT<sub>2</sub>, show zero

213 bandgap structure, being similar to graphene. Bandgap modulation is desired for applications

214 of TMDs in nano-devices under certain circumstances due to the requirement of tunable

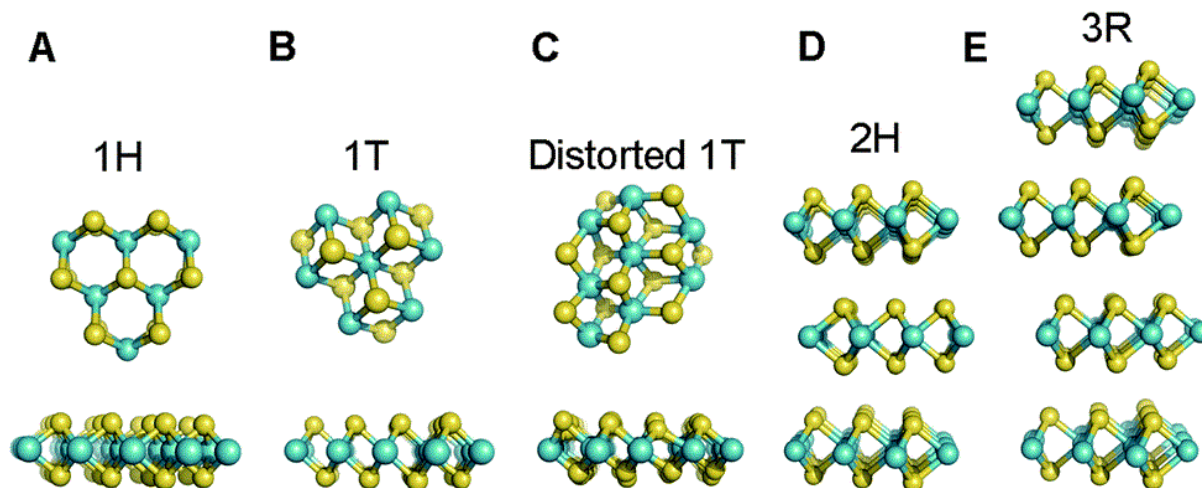
215 electronic properties. Therefore, bandgap modulation by strain engineering, electric field

216 control, alloying and hybrid system fabrication has been studied.

217 MoS<sub>2</sub> is considered as a typical representative TMD and has been recently intensively studied.

218 MoS<sub>2</sub> has transition bandgap of 1.2 eV~1.9 eV with the thickness decreased from bulk or few-

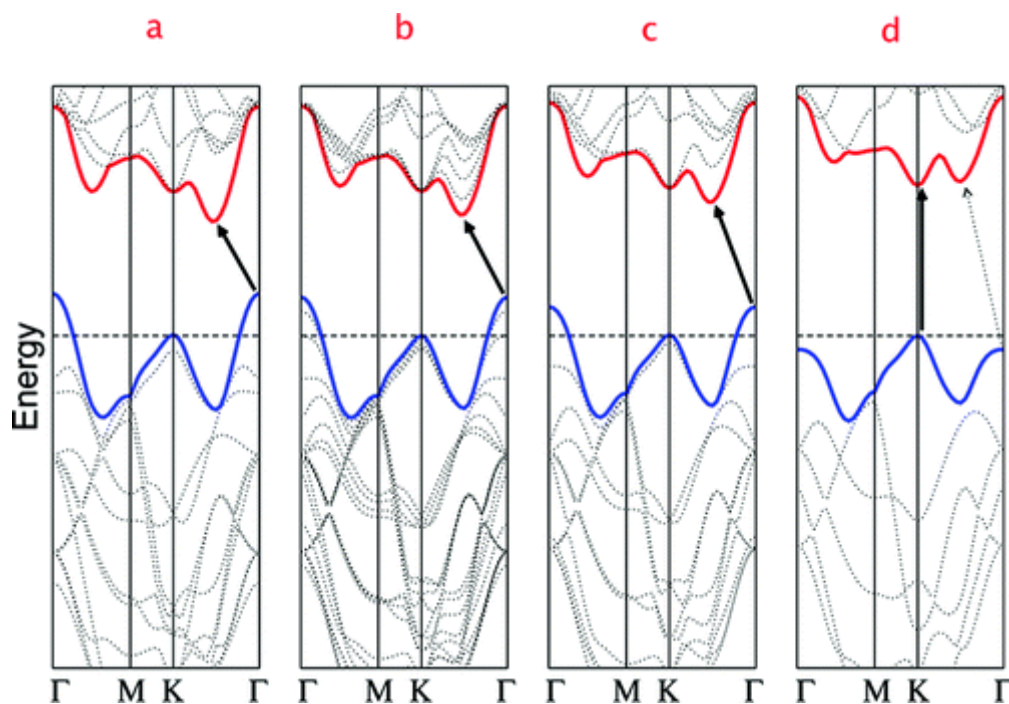
219 layer to monolayer. The optical properties of MoS<sub>2</sub> depends on its bandgap structures. With



220

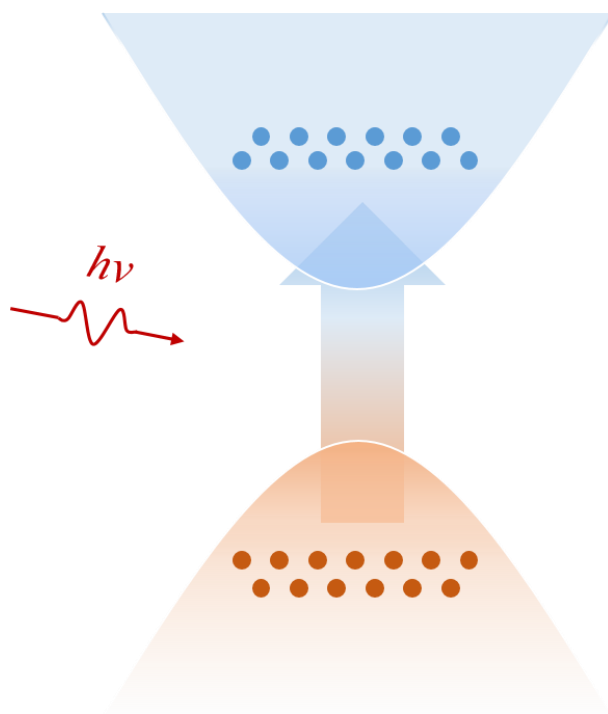
221 **Figure 6.** structures of the TMDs.

222 bandgap ranges from 1.2 eV to 1.9 eV, corresponding to wavelengths ranging from 652.6 nm  
 223 to 1033.3 nm. Linear absorption in the valence band occurs with incident light whose photon  
 224 energy is higher than 1.2 eV. Photocurrent is generated from the electrons in the conductive  
 225 band, as shown in [Figure 8](#). Such optoelectronic property and the electrical conductance, as  
 226 well as carrier mobility of MoS<sub>2</sub> nanosheets show great potential in photodetection with wide  
 227 band response and high sensitivity.



228

229 **Figure 7.** Electrical properties of the layered MoS<sub>2</sub>



230

231 **Figure 8.** Non-equilibrium carrier generated by incident light

232 2.1.3. Other novel 2D materials

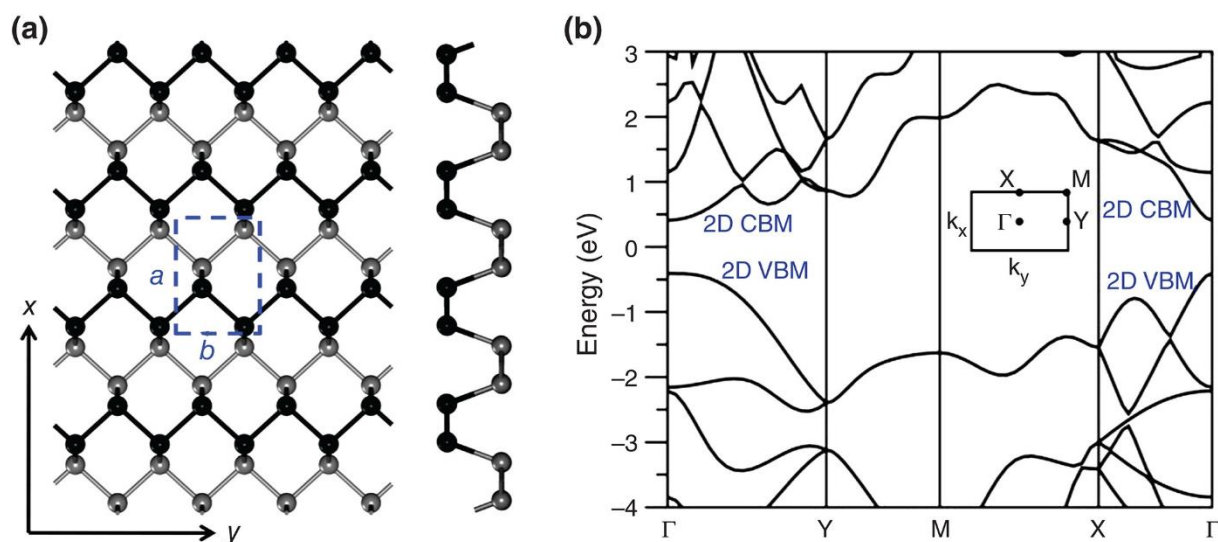
233 Recently 2D materials composed of group-IV (Si, Ge and Sn) elements have also emerged.  
234 Silicene and germanene has similar structure as graphene with honeycomb lattice arranged in-  
235 plane and Van der Waals bond between adjacent layers. They have application potential in the  
236 integrated circuits due to their Si-technology compatibility. Another group IV atomic material  
237 that has been intensively studied is stanine whose structure also resembles graphene with two  
238 common allotropes:  $\alpha$ -tin with face-centered cubic lattice like diamond and  $\beta$ -tin with face-  
239 centered tetragonal lattice.

240 Another category of novel 2D materials, the black phosphorus (BP), was first synthesized a  
241 century ago and recently attracts lots of interest due to its direct bandgap in bulk and  
242 monolayer ranges from 0.33 eV to  $>1$  eV. BP could thus be applied in the mid-infrared  
243 photodetectors. Scotch tape method could achieve exfoliated monolayer BP and thickness of  
244 monolayer BP could be 0.7-0.85 nm. Structure of the BP is shown in [Figure 9](#). As for the  
245 electric properties of BP, the electron and hole mobility  $S$  were measured to be  $>1000 \text{ cm}^2\text{V}^{-1}\text{s}^{-1}$   
246  $\text{s}^{-1}$  at room temperature with high on/off ratio in the application and on/off ratio, together

247 with its band structure, making it suitable for photodetection.[100, 101]

## 248 2.2. Fundamentals of ferroelectrics

249 Ferroelectrics are a group of materials with asymmetry lattice structure, resulting in dipoles in  
 250 the lattice and capable of being modulated by the external stimuli. One of the most typical  
 251 characteristics of ferroelectrics is the spontaneous polarization, i.e. the positive and negative  
 252 charge centers in the original cell of the lattice do not coincide without external electric field



253

254 **Figure 9.** (a) Lattice structure and (b) electrical band structure of phosphorene.

255 **Table 1.** Bandgap of typical  $\text{MX}_2$  ( $\text{M}=\text{Mo}, \text{W}$ ;  $\text{X}=\text{S}, \text{Se}, \text{Te}$ )

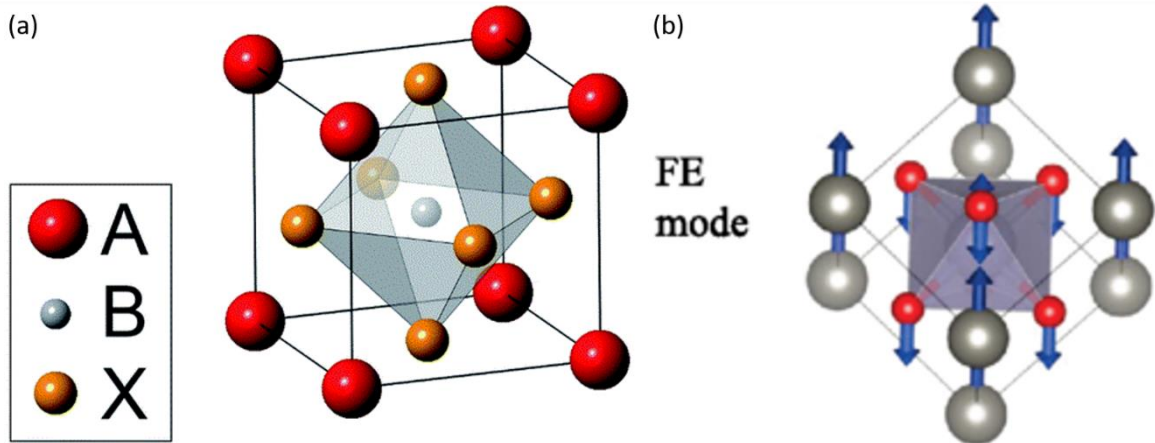
TMDs	Number of layers	Band gap [eV]	Reference
$\text{MoS}_2$	monolayer	1.9-1.95	[150, 151]
$\text{MoS}_2$	bulk	1.20-1.29	[98, 152, 153]
$\text{MoSe}_2$	monolayer	1.44-1.55	[154, 155]
$\text{MoSe}_2$	bulk	1.1	[154]
$\text{WS}_2$	monolayer	1.80-2.05	[155, 156, 157]
$\text{WS}_2$	bulk	1.30-1.35	[153, 158]
$\text{WSe}_2$	monolayer	1.65-1.70	[159, 160]
$\text{WSe}_2$	bulk	1.2	[161]
$\text{MoTe}_2$	monolayer	0.90-1.10	[162, 163, 164, 165]
$\text{MoTe}_2$	bulk	0.88	[164, 165]
$\text{WTe}_2$	monolayer	0.18	[166, 167]
$\text{WTe}_2$	bulk	0.7-0.81	[166, 168]

256 within a certain temperature range. Other properties including the dielectricity,  
257 piezoelectricity, pyroelectricity and related effects (for instance electro-optical effect,  
258 acoustic-optical effect, photorefractive effect as well as nonlinear optical properties) make  
259 them particularly suitable for varieties of applications. These phenomena related to the lattice  
260 structure of ferroelectrics could be further investigated by “ferroelectric domain” structure in  
261 the materials. Domains are defined as small region of lattice with the same polarization  
262 direction, which is correlated to the lattice asymmetry, piezoelectricity and ferroelectricity of  
263 the materials. According to the lattice structure, ferroelectrics are categorized into perovskite,  
264 pyrochlores, the tungsten-bronze group and the bismuth layer structure group. In combination  
265 with 2D materials, the ferroelectrics could be applied as the functional layer due to the alter of  
266 polarization with external electric field switching. Typical ferroelectrics including inorganic  
267 perovskites with  $ABO_3$  structure, like  $Pb(Zr,Ti)O_3$  (PZT),  $PbTiO_3$  (PT),  $Pb(Mg,Nb)O_3$ - $PbTiO_3$   
268 (PMN-PT),  $BaTiO_3$  (BTO),  $(Bi,Na)TiO_3$ - $BaTiO_3$  (BNT-BT),  $(K, Na)NbO_3$  (KNN) and  
269 organic polymers like Poly(vinylidene fluoride) (PVDF) and Methylammonium Lead Iodide  
270 ( $MAPbI_3$ ).

### 271 2.2.1. $ABO_3$

272 Among all the ferroelectrics, the inorganic ferroelectrics with genetic composition of  $ABO_3$   
273 are the most studied and most widely applied. Library of  $ABO_3$  perovskite contains  
274 compounds like PZT, PT and BTO, as shown in [Figure 10\(a\)](#). [102, 103, 104] These  $ABO_3$   
275 ferroelectrics could be further divided into lead-containing and lead-free compounds. PZT is  
276 the dominating ferroelectric materials in the high-end commercial market for its remarkable  
277 ferroelectricity and mature ceramic fabrication process. Despite the high performance of  
278 devices with lead-containing materials, another group of lead-free oxides like BTO, BNT and  
279 BFO are attracting increasing attentions due to their environment-friendly feature and good  
280 ferroelectric properties.

281 A-site driven ferroelectric distortions is shown in [Figure 10\(b\)](#). [105] The ferroelectric domain



282

283 **Figure 10.** Structure of ABO<sub>3</sub> perovskite

284 strongly impacts the ferroelectricity. Ferroelectric domain refers to a region where the  
285 polarization shares the same orientation without any external stimuli. That is to say, all the  
286 domain states have the same energy. Furthermore, if an external electric field was applied to  
287 the ferroelectric material, polarization tends to be aligned to the same orientation and the free  
288 energy would be weakened. Consequently, the permanent polarization could be achieved by  
289 applying a large enough external electric field. The most important characteristic of the  
290 ferroelectrics is the hysteresis loop, known as the fingerprint of the ferroelectricity, which  
291 reveals the non-linear relation between the polarization and external electric field. In addition,  
292 the direction of polarization could be reversed by switching the electric field. Different  
293 crystallographic forms (e.g. texture, polycrystalline and epitaxial) may significantly influence  
294 the material properties and their applications. For instance, the grain and grain boundaries  
295 have modulation effects on the polarization and other parameters.[106] Defects in the nano  
296 layer structure could lead to stress inside the material and, as well, impact the device  
297 performances.[107]

298 Other common methods to characterize the ferroelectricity of materials include the  
299 capacitance-voltage (C-V) characteristics, also known as the “butterfly curve”, leakage  
300 current and fatigue measurements. Key parameters of ferroelectric materials include the

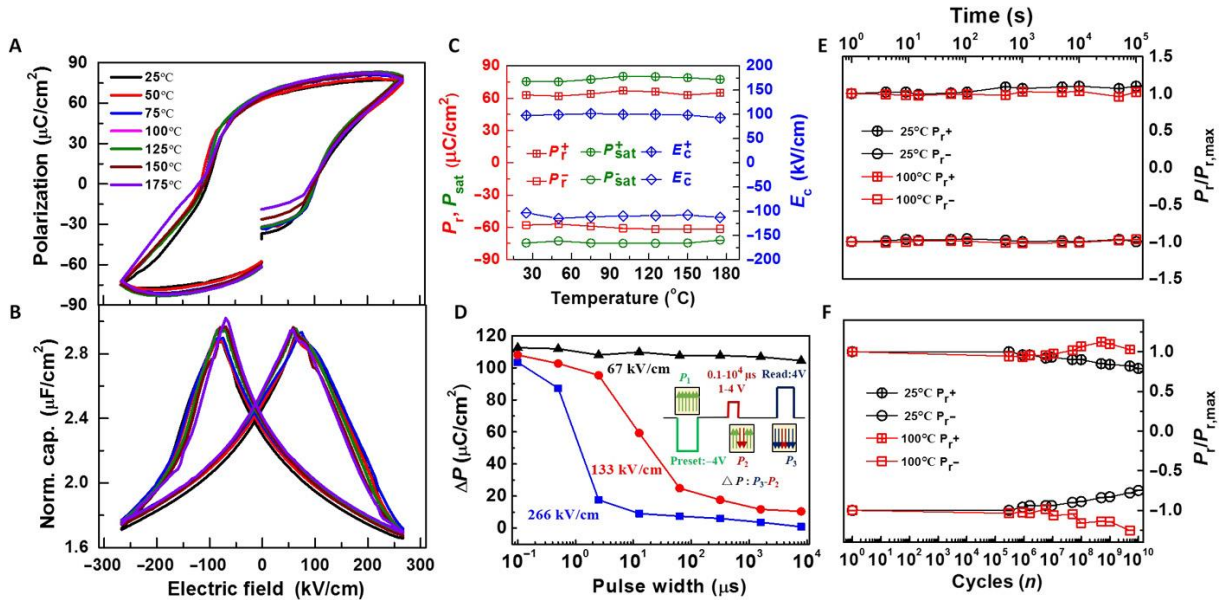


301 dielectric constant, coercive field, remnant polarization etc. [Figure 11](#) is the measurements of  
 302 PZT layer. [108]

303 Most of the ferroelectrics have intrinsic large bandgap (see [Table 2](#)). Ferroelectric thin films  
 304 possess optical properties including high transparency at visible band, high dielectric constant  
 305 nonlinear optical response which are particularly useful in lasers for nonlinear optical  
 306 frequency conversion. In ferroelectric materials, polarization depends on the electric field and  
 307 incident light, which could be expressed as

$$308 \quad \vec{P} = \varepsilon_0 \chi^{(1)} \cdot \vec{E} + \varepsilon_0 \chi^{(2)} : \vec{E}\vec{E} + \varepsilon_0 \chi^{(3)} : \vec{E}\vec{E}\vec{E} + \dots = P^{(1)} + P^{NL}$$

309 where the first term is the linear optical property of with  $\chi^{(1)}$ . The  $\chi^{(2)}$  and  $\chi^{(3)}$ , are the



310  
 311 **Figure 11.** Electrical properties of PZT thin film. (a) $P$ - $E$  and (b) $C$ - $E$  hysteresis loops at  
 312 various temperatures. (c) Remnant, saturation polarizations, and coercive field as functions of  
 313 temperature. (d) PUND switching polarization as a function of pulse width at different  
 314 voltages. The inset shows the measurement sequence. Retention (e) and fatigue (f)  
 315 measurements at two typical temperatures second- and third-order nonlinear optical  
 316 susceptibilities, which correspond to nonlinear optical properties of the material. The second  
 317 order nonlinearity could induce the sum- and difference-frequency generation, Raman  
 318 scattering, Brillouin scattering and optical parametric oscillation (OPO) etc. For the third

319 **Table 2.** Bandgap of the typical ferroelectrics

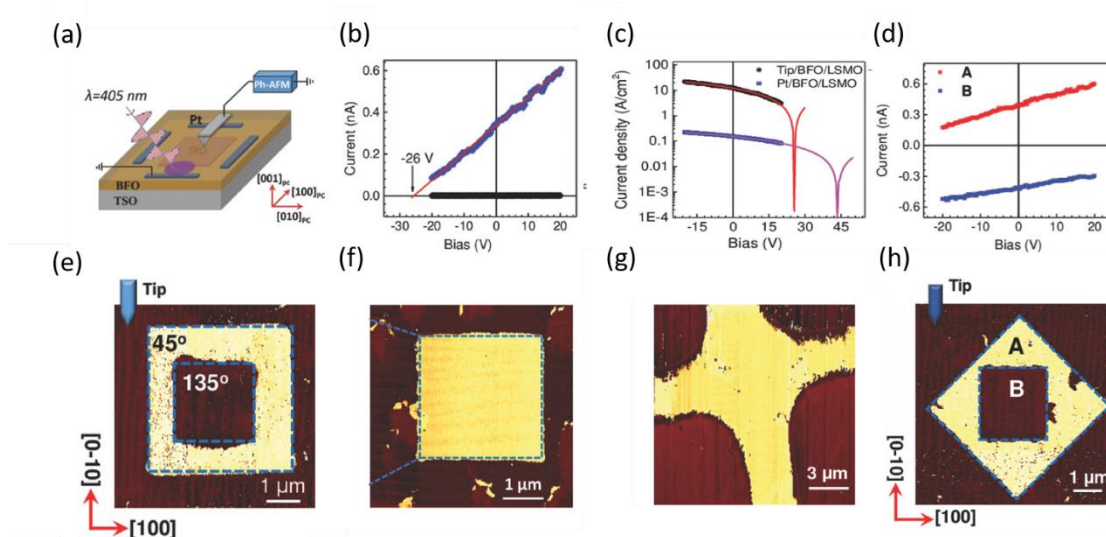
Ferroelectrics	Band gap (eV)	Reference
PZT (Pure)	3.4-4.0	[169, 170, 171]
PZT (Doped)	2.74-3.10	[169]
BTO	2.6	[172]
R <sup>+</sup> BFO	2.65-2.82	[173, 174]
T <sup>+</sup> BFO	3.1	[173]
HZO	bulk	[175][175]

320 order nonlinearity of the material, phase conjugation, four-wave mixing and nonlinear  
321 absorption could be observed.

322 Polarization of the domains could be modulated by the external optical field. [2, 109] Incident  
323 light interacts with ferroelectrics generally in two ways. One is the thermal induced  
324 polarization reverse. The incident light with high energy intensity illuminating on the  
325 ferroelectrics, which results in continuous increase of temperature in local ferroelectrics and  
326 eventually induces polarization switches.[110, 111] It is noticed that such thermal induced  
327 polarization switch is irreversible. The other method for light induced polarization switch is  
328 based on the open circuit voltage generated from the ferroelectrics, which is also known as  
329 bulk photovoltaic (BPV) effect.[112] Li *et al.* has reported the polarization switch by BPV  
330 effect in BiFeO<sub>3</sub>. [113] With light on the surface of ferroelectrics, equilibrium carriers were  
331 generated and thus induce photo current  $I_{ph}$  in the layer. A build-in electric field was  
332 established along the direction of photo current which is, equivalently, considered as a current  
333 source. If the build-in electric field could be raise to values higher than the coercive field,  
334 polarization of the ferroelectrics can be switched. It is worth mentioning that the polarization  
335 is reversible with incident light illuminating on different regions. Moreover, controlling of the  
336 strong laser field, tip-enhancement of the light as well as tuning illumination area could also  
337 achieve reversible ferroelectric polarization switching, as shown in [Figure 12](#). [114]

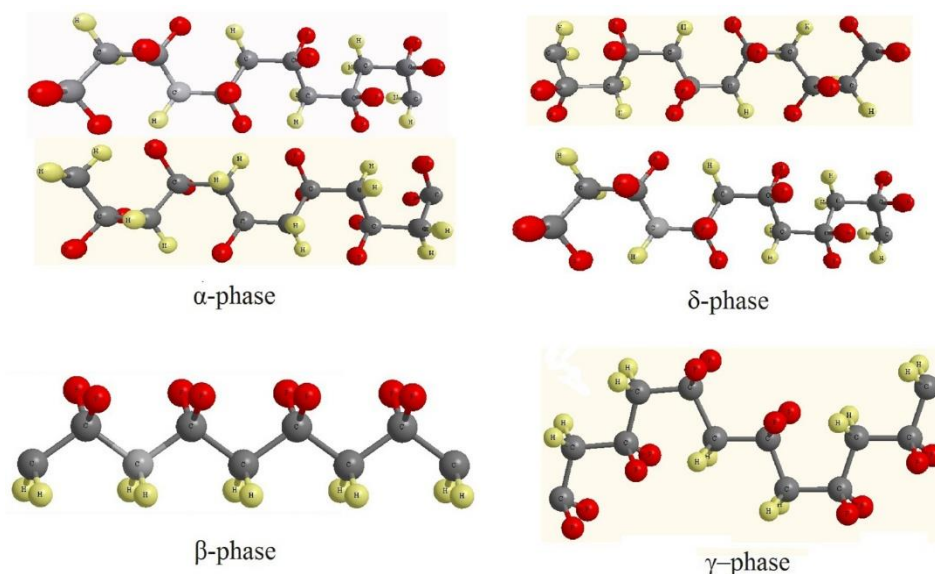
338 2.2.2. Ferroelectric Polymers

339 Moreover, organic ferroelectric polymers have also been studied due to their good mechanical  
 340 property and flexibility. The organic ferroelectric materials are represented by PVDF and its  
 341 derives. PVDF is one of the most studied material. There are four typical lattice structure in  
 342 PVDF including  $\alpha$ ,  $\beta$ ,  $\gamma$  and  $\delta$  phase, which is also known as the I, II, III and IV phases.  
 343 Structure of PVDF-TrFE was shown in [Figure 13](#). The  $\alpha$ -PVDF forms into orthorhombic cell  
 344 with two chains packing in opposite directions resulting in canceling of the dipole moments,  
 345 which consequently makes the  $\alpha$ -phase PVDF non-polar and paraelectric.  $\beta$ -PVDF shares o-  
 346 phase as well yet the structure of the lattice is in all-trans planar zigzag conformation with  
 347 fluorine atoms on one side.  $\beta$ -PVDF could thus achieve the highest dipole moment and



348  
 349 **Figure 12.** Various methods for the light induced polarization in ferroelectric BFO layer. (a)  
 350 Schematic illustration of the device and the light incidence. (e) is polarization switching  
 351 generated from the polarized incident light. (b) is Local current-voltage characteristics with  
 352 and without illumination at tip-enhancement method and (f) is the corresponding PFM result.  
 353 (c) is the current density-voltage dependence of tip/BFO/SRO and the Pt/BFO/SRO capacitors  
 354 and (g) is the PFM amplitude which demonstrated polarization switching with illumination as  
 355 a result of photocurrent density. (d) and (h) are the polarization switching via tuning  
 356 illumination.

357



358

359 **Figure 13.** Structure of PVDF crystalline.

360 become the most popular structure of PVDF with the best ferroelectricity and piezoelectricity  
 361 among all the phases. Crystalline PVDF with  $\gamma$ -phase is monoclinic with partial dipole  
 362 moment, which also show ferroelectricity. The  $\delta$ -phase structure resembles the  $\alpha$ -phase but  
 363 with the second chain rotating  $180^\circ$  along the chain axis. Such structure could result in the  
 364 polar behavior and show ferroelectric property. P(VDF-TrFE) polymer is composed of PVDF  
 365 and TrFE, which is of the most popular ferroelectric polymers among the PVDF based  
 366 materials.

367 Incident photons with high energy like X-ray could generate defects in P(VDF-TrFE) and free  
 368 carriers generated have impact on the reversal of polarization. It was reported that with X-ray  
 369 illuminating on the polarized P(VDF-TrFE) films, a clear phase difference of  $180^\circ$  as well as  
 370 domain boundaries was observed. The loss in ferroelectricity will significantly reduce the  
 371 poled domain area with X-ray irradiation and the domains would be rarely poled after  
 372 illumination for 60 minutes. [115]

### 373 2.3. 2D materials/Ferroelectrics hybrid system

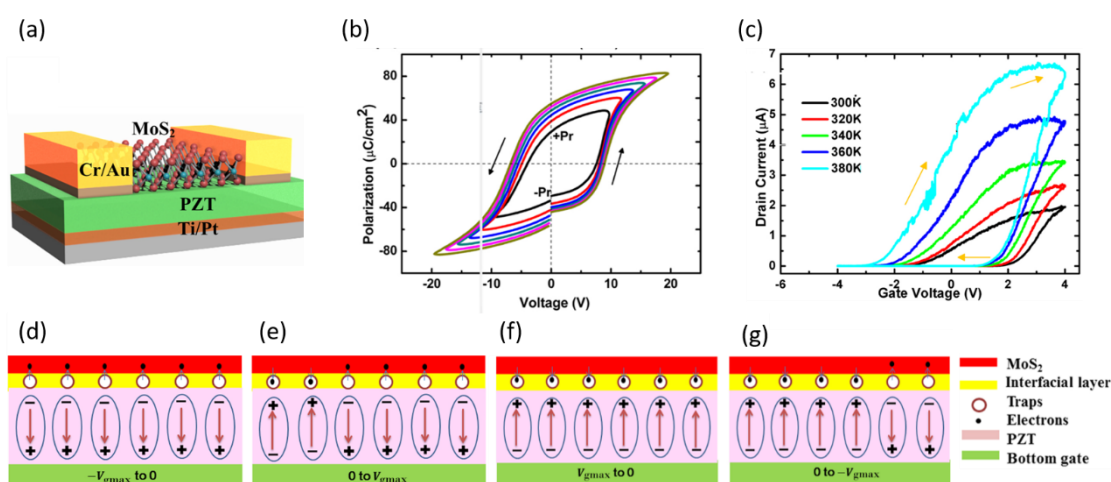
374 Compared to 2D materials on  $\text{SiO}_2/\text{Si}$  substrates, suspended counterparts  $\text{MoS}_2$  has enhanced  
 375 conductivity. However, if one changes the supporting substrates from  $\text{SiO}_2/\text{Si}$  to other

376 functional ones, the properties of 2D materials and thus related device performances could be  
 377 effectively modulated. In addition to holding the 2D materials, these functional substrates  
 378 play an important part in mechanical, chemical, electronic and optoelectronic properties of the  
 379 2D nanosheets. Defects and impurity at the interface as well as the lattice mismatch between  
 380 the MoS<sub>2</sub> and substrate could all impact the structure of the nanosheets. Then the related  
 381 charge transfer, interface strain, dielectric screening effect, as well as the optical interference  
 382 in the 2D semiconductor subsequently impact the device performances.

### 383 2.3.1. Electrical interaction of 2D/ferroelectrics hybrid system

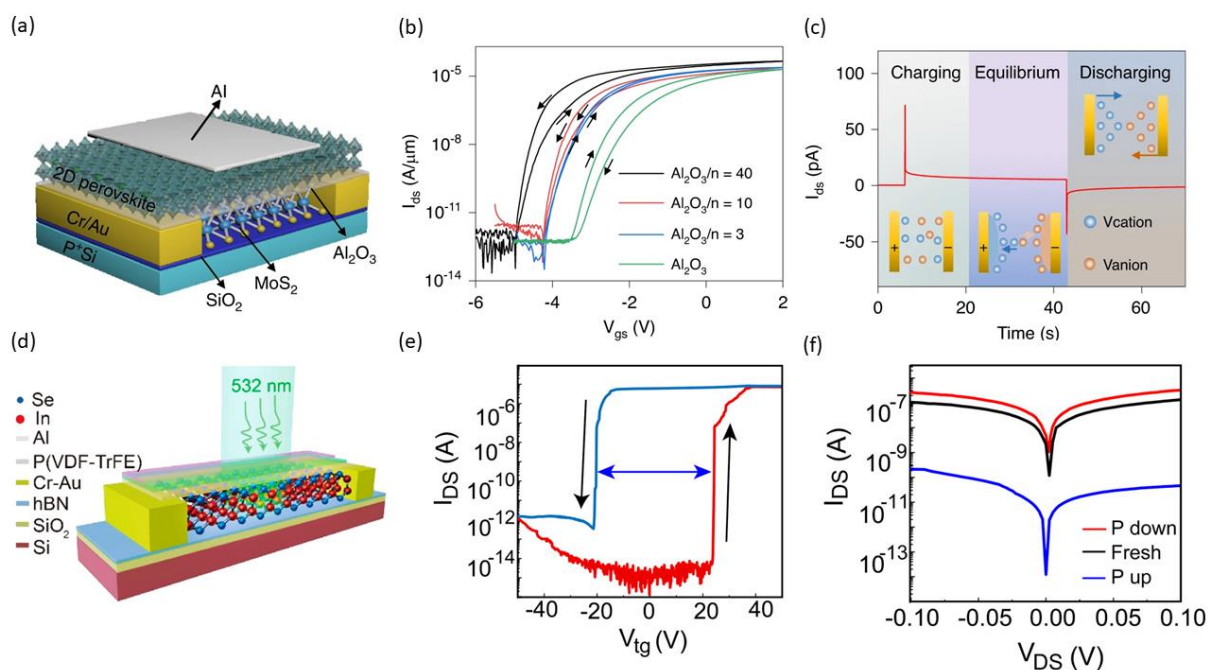
384 Polarization switching in ferroelectrics has been proved to be able to establish a build-in  
 385 electric field in 2D materials, which could further modulate the electrical properties of the 2D  
 386 materials.

387 Therefore, FETs combining 2D materials and ferroelectric layers has been investigated. One  
 388 of the most typical phenomena observed in the early studies was that the clock-wise hysteresis  
 389 loop in the transfer property of FET devices, as shown in [Figure 14](#).<sup>[116]</sup> This hysteresis loop  
 390 was believed to be originated from adsorbents of water molecules rather than ferroelectric



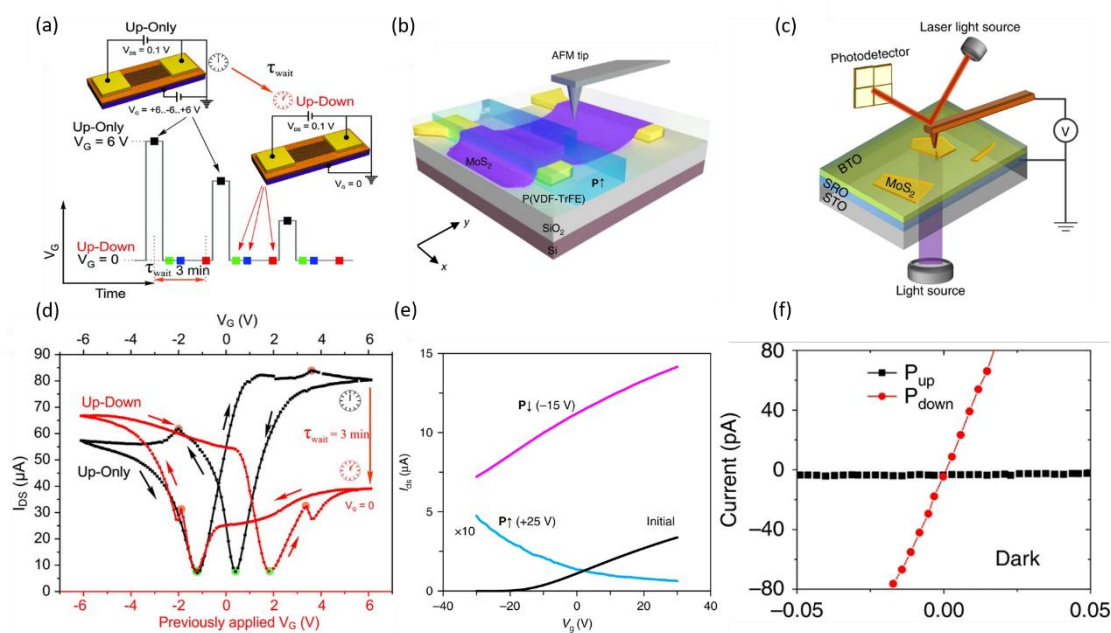
391  
 392 **Figure 14.** Hysteresis behaviors induced by the interfacial states of MoS<sub>2</sub>/PZT FETs. (a) is  
 393 the devices structure. (b) is the polarization-voltage characterization of PZT film and (c) is the  
 394 transfer characteristics of the device with anti-hysteresis loop. (d)-(g) is the physical  
 395 mechanism of charge trapping and de-trapping at the interface of MoS<sub>2</sub>/PZT hybrid system.

396 polarization switching which should induce anti-clockwise loop [153,154]. Such clockwise  
 397 hysteresis was also observed in other 2D materials/ ferroelectrics hybrid system. In addition to  
 398 water molecules absorbents, other possible reasons like oxide charge trapping and surface  
 399 charge trapping are also discussed. [117, 118] Hysteresis in ferroelectric devices have  
 400 undermined the reliability of the devices and scientists have dedicated to solve this issue. Jang  
 401 et al. has proposed a probable method to eliminate the hysteresis generated from charge  
 402 trapping in the ferroelectrics. [119] In the devices contain ferroelectric layer, two hysteresis  
 403 loops with opposite direction exist which is the loop induced by ionic migration in 2D  
 404 ferroelectrics and loop induced by charge trapping, respectively. These two negative effects  
 405 might neutralize with each other by modulating the activation energy for ionic migration in



406  
 407 **Figure 15.** (a) MoS<sub>2</sub> phototransistor with Al<sub>2</sub>O<sub>3</sub>/2D perovskite heterostructure dielectric. (b)  
 408 Transfer characteristics of the devices. The neglectable hysteresis loop is achieved. (c) is the  
 409 schematic illustration of charging-discharging process. (d) is the device structure of InSe  
 410 photodetectors gated by P(VDF-TrFE). (e) is the anti-clockwise memory window achieved  
 411 with bias voltage switching from -40 V to 40 V and (f) is the output characteristics of the InSe  
 412 FET with different polarization states.

413 ferroelectrics, see in [Figure 15\(a\)](#). These rectified devices have proved excellent rectifying  
 414 characteristics and high performance in photodetection. [120] InSe photodetectors gated by  
 415 ferroelectrics (shown in [Figure 15\(b\)](#)) has reported anti-clockwise hysteresis in the  
 416 experiments, as shown in [Figure 15\(c\)](#).  
 417 Despite the charge trapping induced clockwise hysteresis, the hysteresis generated  
 418 ferroelectrics could also be observed in the devices as shown in [Figure 15 \(d\)](#). Anti-clockwise  
 419 memory window was observed with bias applied from -40 V to 40 V, shown in [Figure 15 \(e\)](#)  
 420 and the electrical properties varied with different polarization states, see [Figure 15 \(f\)](#).  
 421 In addition to the hysteresis observed in 2D materials and ferroelectrics hybrid system. The  
 422 dielectric screening effect is capable of modulating the electron-electron interactions as well  
 423 in the layer adjacent to the substrate, leading to band structures variation and Fermi level shift.  
 424 Moreover, the electronic transport of 2D materials could be tuned by ferroelectrics with

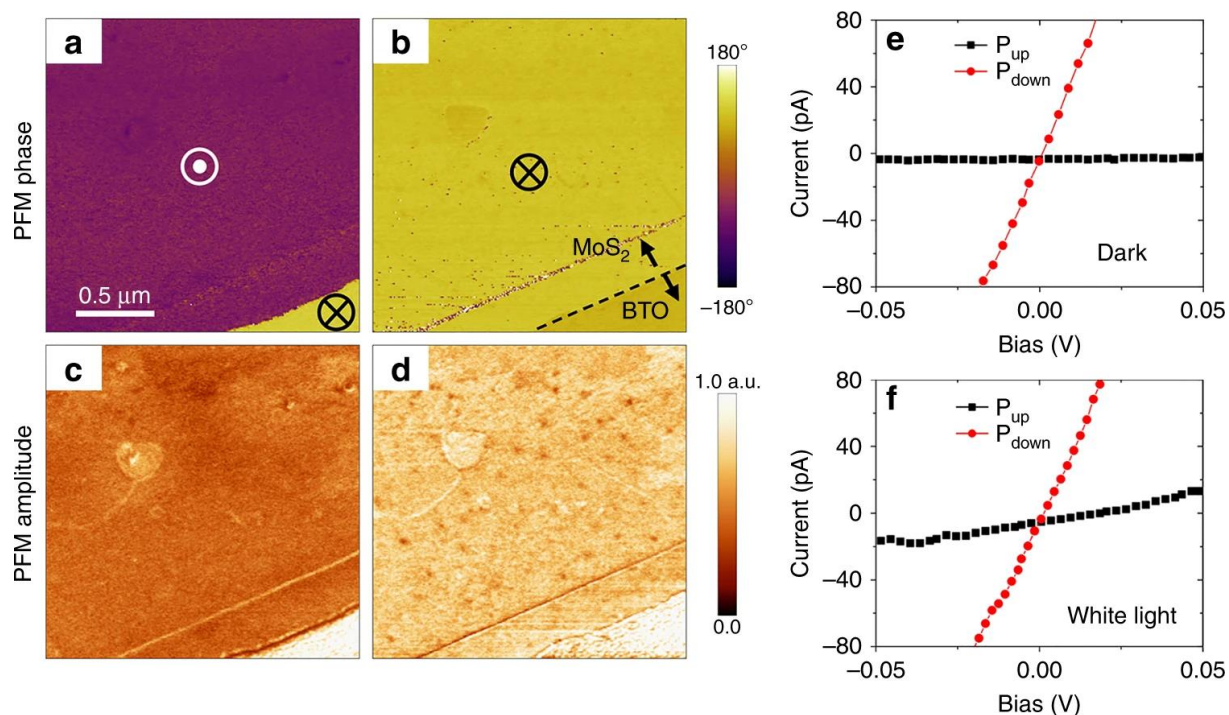


425  
 426 **Figure 16.** Electrical properties of the devices modulate by ferroelectric polarization. (a) and  
 427 (d) are demonstrated the hysteresis reversal in graphene-PZT FeFETs and the  $I_{ds}$ - $V_{gs}$  voltage  
 428 of +25V and down poling voltage of -15V.[122] (c) and (f) demonstrated the polarization  
 429 induced dark current variation in the MoS<sub>2</sub>/BTO FETs.[113]

430 polarized-up and -down were measured.[121] (b) and (e) is the  $I_{ds}$ - $V_{gs}$  characteristics of  
 431 MoS<sub>2</sub> FETs with PVDF as ferroelectrics and polarized by up poling polarization, as shown in  
 432 [Figure 16](#). [121, 122, 113] For example, the carrier type of the 2D materials could be  
 433 modulated by the ferroelectric polarization switching. [123] Reversal of the polarization of the  
 434 underneath ferroelectric film has led to the conversion of graphene from p-type to n-type,  
 435 resulting in the reversible switching of the resistance in graphene. Similar results has been  
 436 achieved by other researches with different 2D materials like MoS<sub>2</sub>, MoTe<sub>2</sub> and InSe. [122, 45,  
 437 120] Low-voltage operation could be achieved with high-k ferroelectrics and the retention  
 438 time of the devices could be improved [159].

### 439 2.3.2. Optoelectronic properties in 2D/ferroelectrics hybrid system

440 With 2D semiconductor in combination with ferroelectric layers, memory devices are capable  
 441 of being written and erased both electrically and optically. [14] Moreover, ferroelectric films  
 442 would be much easier to achieve polarization reversal than the pristine ferroelectrics with the  
 443 assistance of 2D materials due to the compensation charge generated from 2D materials with  
 444 incident light. As shown in [Figure 17](#), MoS<sub>2</sub>/BTO/SRO structure was fabricated and the



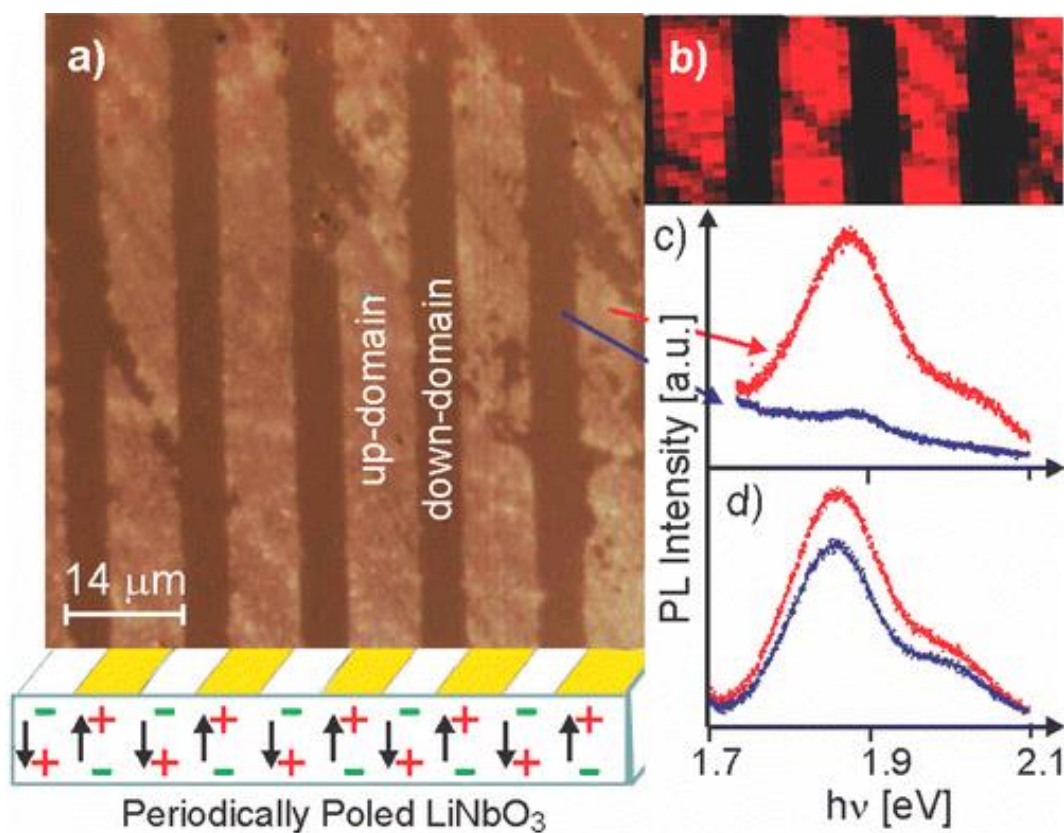
445

446 **Figure 17.** Polarization switching induced by external electric field. [124]



447 underneath BTO was able to be polarized by external electric field with MoS<sub>2</sub> on top. Ultra-  
 448 violet (UV) light irradiation was then applied in the structure and optical induced polarization  
 449 reversal was observed, as shown in [Figure 17\(b\)-\(e\)](#). The illumination of the structure leads to  
 450 an accumulation of photon-generated carrier at the interface. Charge accumulation could  
 451 modulate the built electric field and consequently change the electric field applied on the BTO,  
 452 resulting in polarization switching in the BTO layer.[124] Polarization could also be  
 453 modulated by the intensity of incident light and the piezo-response microscopy (PFM)  
 454 amplitude signal, which varied because the photon-induced carriers devoted to the modulation  
 455 of the electric field at the interface. Similar X-ray induced polarization has been studied with  
 456 different ferroelectrics. [115]

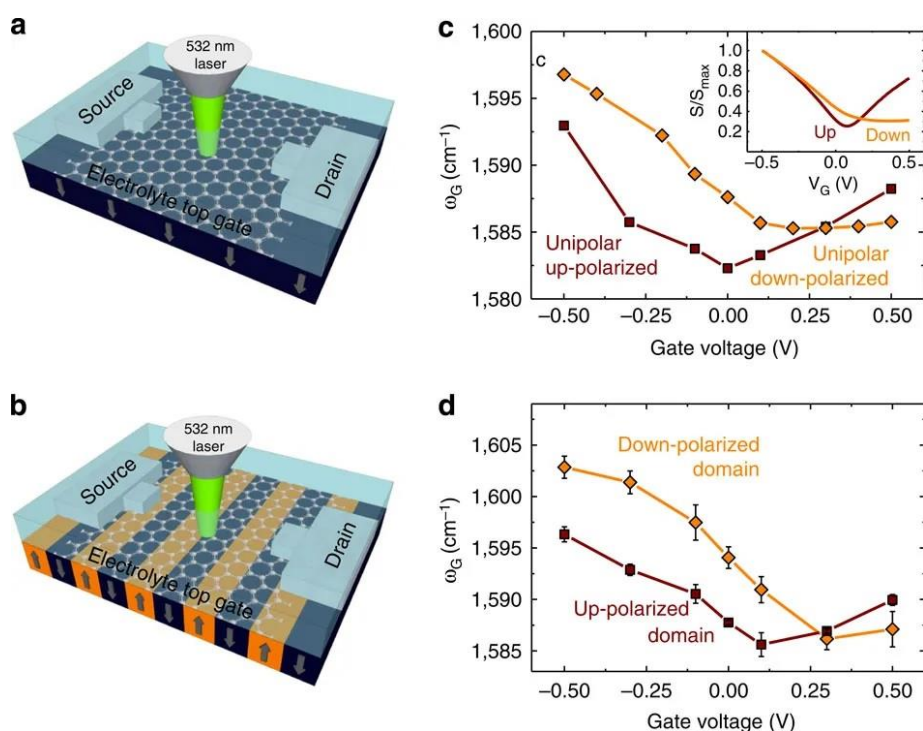
457 In addition to photon induced polarization reversal with assistance of 2D materials, the impact  
 458 on optoelectronic properties of 2D materials caused by ferroelectrics has also been observed.



459  
 460 **Figure 18.** Optical microscopy of selective deposited MoS<sub>2</sub> on pre-polarized LN and the  
 461 photoluminescence of the MoS<sub>2</sub> island. [125]

462 LiNbO<sub>3</sub> (LN) is a ferroelectric material widely applied in optical devices thanks to its  
 463 outstanding nonlinear optical properties. LN could be pre-polarized and applied as substrates  
 464 for 2D materials. [125] MoS<sub>2</sub> was deposited on the periodically poled LN substrate. Selective  
 465 growth of the MoS<sub>2</sub> was observed where enhance deposition of MoS<sub>2</sub> was found on the  
 466 polarization “up” domain compared to polarization “down” domain. Optical properties of the  
 467 deposited MoS<sub>2</sub> are influenced by the polarized LN, as illustrated in [Figure 18](#). Polarization of  
 468 the LN substrate could not only influence the growth but also the carrier transport of the MoS<sub>2</sub>  
 469 overlayer.

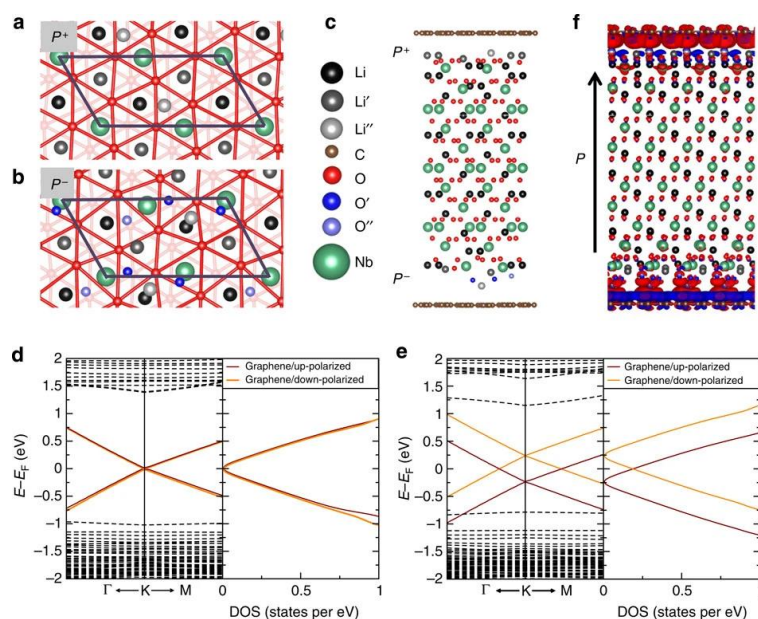
470 Chemical vapor deposition (CVD) fabrication of MoS<sub>2</sub> requires high temperature of over  
 471 600°C, which is higher than the Curie temperature of many ferroelectrics and leads to the loss  
 472 of polarization. Therefore, an alternative method, namely mechanical transfer for the  
 473 realization of MoS<sub>2</sub> on ferroelectrics has been developed. [126] For instance, CVD grown  
 474 WS<sub>2</sub> monolayer was mechanically transferred to a pre-polarized ferroelectric substrate and  
 475 photoluminescence (PL) characterization of the WS<sub>2</sub> was measured. The spatial variation of



476

477 **Figure 19.** Ferroelectrically driven carrier density modulation in graphene

478



479

480 **Figure 20.** Theoretical study of the ferroelectrically control of carrier density in graphene  
 481 with first-principle DFT.

482 PL spectra indicates the effective modulation of WS<sub>2</sub> monolayer by ferroelectric polarization.  
 483 [126]

484 Photo-induced polarization in 2D/ferroelectrics hybrid structure has been proved to be  
 485 dependent on the intensity of incident light. The ferroelectrics could also drive spatial carrier  
 486 density modulation in the 2D materials of the hybrid structure,[127] as shown in [Figure 19](#)  
 487 reported by Baeumer *et al.* Characteristic peaks of Raman spectra shift in different  
 488 polarization domain of the LN crystal. Two orders of magnitude carrier density difference  
 489 were observed, which could origin from the graphene/LN interfacial chemistry effects. The  
 490 interaction has also been theoretically calculated by the first-principle density-functional  
 491 theory (DFT) calculations, as shown in [Figure 20](#). Structure of the interface was constructed  
 492 and the polarization was applied, as shown [Figure 20\(f\)](#). Calculation of the carrier density in  
 493 graphene revealed that symmetrical charge densities in graphene was  $6.75 \times 10^{12}$ .

### 494 3. Photodetectors based on 2D materials and 2D materials/ferroelectrics hybrid system

#### 495 3.1. Fundamentals of photodetection

496 2D materials with their superior photonic and optoelectronic properties has been extensively  
497 studied in nano devices. The TMDs nanosheets are a typical group material among the large  
498 amount and types of the 2D materials. The TMDs could be primarily considered as  
499 semiconductors with direct or indirect bandgap. Therefore, the principle and understanding of  
500 conventional semiconductor photodetection could be transferred to TMDs photodetection.  
501 The incident light generates carriers in semiconductors and they are then transported to  
502 electrodes. It is noticed that the signal amplification is sometimes applied in this procedure  
503 particularly in photodetectors due to the requirement of weak signal detection. Photodetection  
504 mechanism mainly consist of the photoconductive effect and photovoltaic effect. There are  
505 three main device structures for semiconductor photodetectors, the PN junction and related  
506 devices, Schottky junctions and field effect transistors.

507 Semiconductors could absorb the illuminated light and transfer photons to signals like voltage  
508 or current. This photodetection process could occur only when the incident photons possess  
509 larger energy than the bandgap of semiconductor materials, i.e.

$$510 \quad \hbar\nu \geq \hbar\nu_0 = E_g \quad (1)$$

511 where the  $\hbar\nu_0$  is the threshold energy that enables the intrinsic absorption. Moreover, for  
512 semiconductors with the indirect bandgap, the probability of the transition is much smaller  
513 than that of direct transitions, due to the participation of the phonons. Other absorption  
514 including exciton absorption, free carrier absorption and impurity absorption. During the  
515 photodetection, electrons in the valence band transit to the conductive band under illumination  
516 and generate extra electrons and holes, leading to signals of current or voltage. Photo-  
517 generated current could be expressed as

$$518 \quad I_c = q\eta \frac{P}{h\nu} \quad (2)$$

519 Consider  $A = \frac{q\eta}{h\nu}$  is the proportionality constant, which represents the sensitivity of the  
 520 photodetector.

521 Mechanism of photodetection mainly includes the photoconductive and the photovoltaic ones.  
 522 The conductivity increases of semiconductors due to light illumination has been briefly  
 523 introduced before (see section 2.3), which is known as the photoconductive effect, as shown  
 524 in [Figure 21](#).

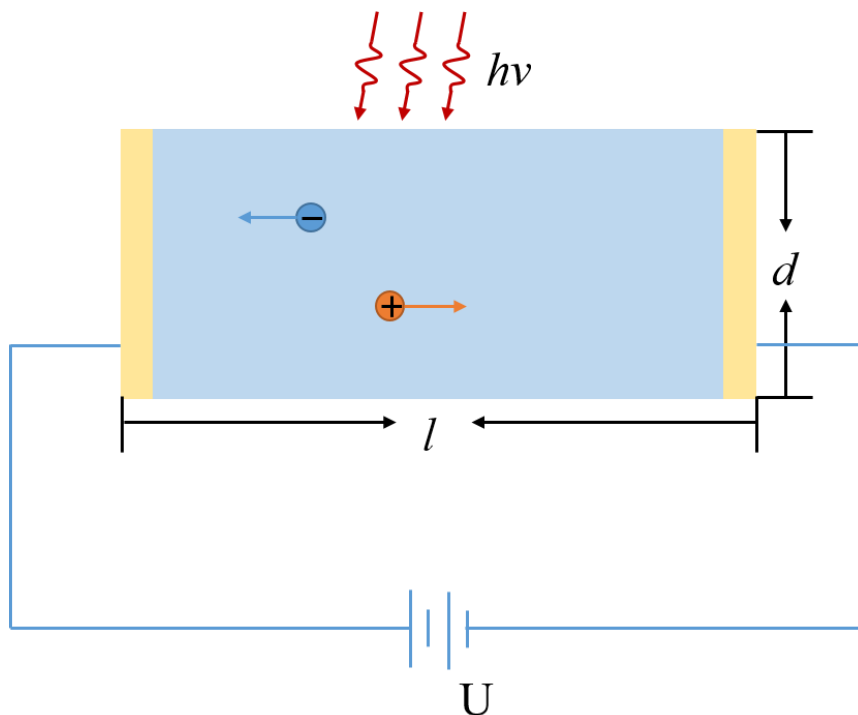
525 The generation rate of the photogenerated carriers is proportional to incident light intensity.  
 526 The photogenerated carriers constantly generate and recombination, the density of photon-  
 527 generated carriers is

$$528 \quad \Delta n_0 = \Delta p_0 = g\tau \quad (3)$$

529 where  $g$  is the generation rate of photogenerated carriers,  $\tau$  is the average carrier life-time.

530 Consider the incident light power of  $P$ ,  $g$  could be written as

$$531 \quad g = \eta \frac{P}{h\nu AL} \quad (4)$$



532

533 **Figure 21.** Basic principle of photoconductive current generation

534 where  $\eta$  is the quantum efficiency, A and L is the cross-section area and the length of the  
 535 material, respectively. Short-circuit photocurrent density with external electric field is

$$536 \quad \Delta J_0 = E \cdot \Delta \sigma = q\tau\eta(\mu_n + \mu_p) \frac{P}{h\nu AL} E \quad (5)$$

537 Electrical conductivity and photocurrent both increase as the intensity of illumination  
 538 augments. Photocurrent is then:

$$539 \quad I_p = \frac{U \Delta \sigma A}{L} = \frac{qUA(\Delta n\mu_n + \Delta p\mu_p)}{L} = \frac{qNU}{L^2}(\Delta n\mu_n + \Delta p\mu_p) \quad (6)$$

540 where N is the number of generated electron-hole pairs;  $\tau_n$  and  $\tau_p$  are corresponding life-  
 541 time of electrons and holes generated, respectively.

542 With illumination on the inhomogeneous semiconductor, the build-in electric field is formed  
 543 and photo-generated current is observed when the circuit is shorted. Such optoelectronic  
 544 effect is photo-voltaic effect.

545 Based on photoconductive and photovoltaic mechanism, different devices are developed, in  
 546 which photoconductors and photodiodes are two typical representatives. Photoconductors are  
 547 based on photoconductivity. Photo-conductors usually has wide band response, relatively high  
 548 operating current and high sensitivity. With the incident light, the non-equilibrium carriers  
 549 increase and consequently improve the conductivity of the materials, and the resistance is thus  
 550 reduced under illumination.[128, 129] The photoconductive effect is sensitive to the  
 551 nanostructure as well as the doping and defects of the semiconductors. Photoresistors based  
 552 on 2D materials with wide band responsivity has been widely studied and reported by  
 553 researchers. [130] It was demonstrated that the 2D materials are able to cover the UV to infra-  
 554 red band with high responsivity and ultrasensitive properties.

555 Photodiodes are based on the photo-voltaic effect, which is also known as barrier-type  
 556 photodetectors. Photodiodes include PN junction, the PIN junction, heterostructure and  
 557 Schottky diodes.

558 Compared to photoconductors which require external voltage, photodiodes have certain  
559 polarities and thus the signals could be transferred without external voltage. Photodiodes also  
560 show fast responsivity and good frequency response.

561 Taking PN junction as an example to explain the photodetection process, the barrier region in  
562 a PN junction shares relatively strong built-in electric field (from n-region point to p-region).  
563 Photo-generated carriers move in opposite directions under the built-in electric field. The  
564 electrons in p-region move to the n-region while the holes enter the p-region. Such movement  
565 of the electrons and holes consequently lead to potential reduction in the n-region and rise in  
566 the p-region. Electromotive force (EMF) across the PN junction generated with illumination  
567 results into a potential drop  $qV_D - qV$  and forward current  $I_F$ . In addition to the photoresistor  
568 and PN diode, another group of devices enable photodetection could be as well studied  
569 profoundly, known as the phototransistors.

### 570 **3.2. Figures of merit in photodetection**

571 The most important parameters for photodetection are identified as speed, responsivity and  
572 sensitivity. Other parameters including quantum efficiency, noise and gain are important  
573 figures of merit as well. It is noted that here we only consider the semiconductor  
574 photodetector to understand the operation of the semiconductor photodetector and figures of  
575 merit for photodetection which are of vital importance to the materials parameters, device  
576 structure and performance. Definitions of the parameters of quantum efficiency, responsivity,  
577 sensitivity, response speed and photo gain are as follows:

578 “Quantum efficiency” could be divided into internal and external quantum efficiency, which  
579 are the most important parameters for semiconductor optoelectronic photodetectors. The  
580 internal quantum efficiency (IQE) is defined as the number of electron-hole pairs generated by  
581 absorbing one incident photon, which is

$$582 \quad IQE = 1 - e^{-\alpha(\lambda)W} \quad (7)$$

583 where  $\alpha(\lambda)$  is the absorption coefficient of corresponding wavelength  $\lambda$ ,  $W$  is the thickness  
 584 of the absorption layer. It is demonstrated that the IQE increases with the absorption  
 585 coefficient or the thickness of the absorption layer grows. In practical applications, there is no  
 586 way for photons reach the absorption layer through the surface of the materials. Photons go  
 587 through a heavily doped contact area with photon loss rather than passing through the surface  
 588 of materials to reach the absorption layer. Simultaneously, the reflection of the surface also  
 589 consumes part of the incident photons. Thus, the external quantum efficiency (EQE) is  
 590 defined as

$$591 \quad EQE = (1 - R_f) e^{-\alpha(\lambda)d} \cdot IQE$$

$$= \frac{I_p/q}{P/h\nu} \quad (8)$$

592 where  $d$  is the thickness of contact area and  $R_f$  is the surface reflectivity on photodetector.  
 593 “Responsivity” of a photodetector is the voltage or current of photodetector output divided by  
 594 the input power, which could be categorized into spectral responsivity ( $R_\lambda$ ) and integral  
 595 responsivity ( $R$ ). If the photo-induced current ( $I_{ph}$ ) is measured with incident power of  $P$ ,

$$596 \quad R = \frac{I_{ph}}{P} \quad (9)$$

597 according to the definition of quantum efficiency, then

$$598 \quad R = EQE \cdot \frac{q}{h\nu} \quad (10)$$

599 where  $q$  is the electronic charge.

600 “Sensitivity” of a photodetector is the minimum photon signal detected under certain  
 601 transmission bandwidth and rate. It measures the photoelectric conversion characteristics, as  
 602 well as the spectral and frequency conversion characteristics.



603 “Response speed” of photodiode is evaluated by the rise/fall time ( $\tau_r/\tau_f$ ) of the detective  
 604 signal. The response speed is defined as the frequency where the photocurrent decreases to  
 605  $1/\sqrt{2}$  from peak in frequency domain. Incident photons will go into the semiconductor  
 606 through the surface layer, then photo-generated carriers and free electron-hole pairs shift  
 607 under the electric field. The time required for incident photons to be transferred to  
 608 photocurrent is the “response time”. Three main factors could affect the response time,  
 609 including the diffusion and transition time in the depletion region, as well as the RC time  
 610 constant of the photodiode.

611 The “noise equivalent power (NEP)” is another key parameter for photodetection, which  
 612 refers to the input signal power which results in a signal-to-noise ratio (S/R) of 1 in a 1 Hz  
 613 output bandwidth. [131]NEP has expressed the sensitivity of photodetectors. Another typical  
 614 parameter being correlated to the NEP is the “detectivity” ( $D^*$ ).

$$615 \quad D^* = \frac{(A \cdot \Delta f)^{\frac{1}{2}}}{NEP} \quad (11)$$

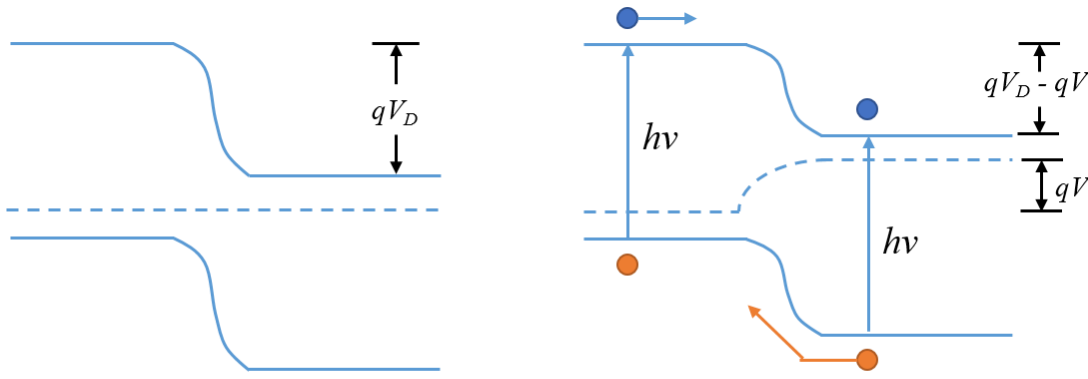
616 where,  $A$  is the area of the photosensitive region and the  $\Delta f$  is the frequency bandwidth of the  
 617 detector.

618 “Photogain” is a benchmarked parameter for photoconductive detectors, which is

$$619 \quad G_{ph} = (I_{ph}/q) / (\Phi_{in} QE) \quad (12)$$

620 where  $\Phi_{in} = \frac{P}{h\nu}$  is the incoming photon flux. Here we bring another definition of External

621 Quantum Efficiency (EQE) for sensitized photoconductors as  $QE = \eta_{trans} \eta_{abs}$ , where  $\eta_{trans}$  is  
 622 the charge transfer efficiency and  $\eta_{abs}$  is the absorption efficiency, which demonstrates the  
 623 number of detected charge carriers per single incident photon. The photogain can also be  
 624 quantified by the ratio of the lifetime of the trapped carriers ( $\tau_{life}$ ) over the drift transit time  
 625 ( $\tau_{transit}$ ). If we take a FET for example, a bias ( $V_{bias}$ ) is applied to a FET device, the  $G_{ph}$  can



626

627 **Figure 22.** Band structure of PN junction and the mechanism of photodetection.

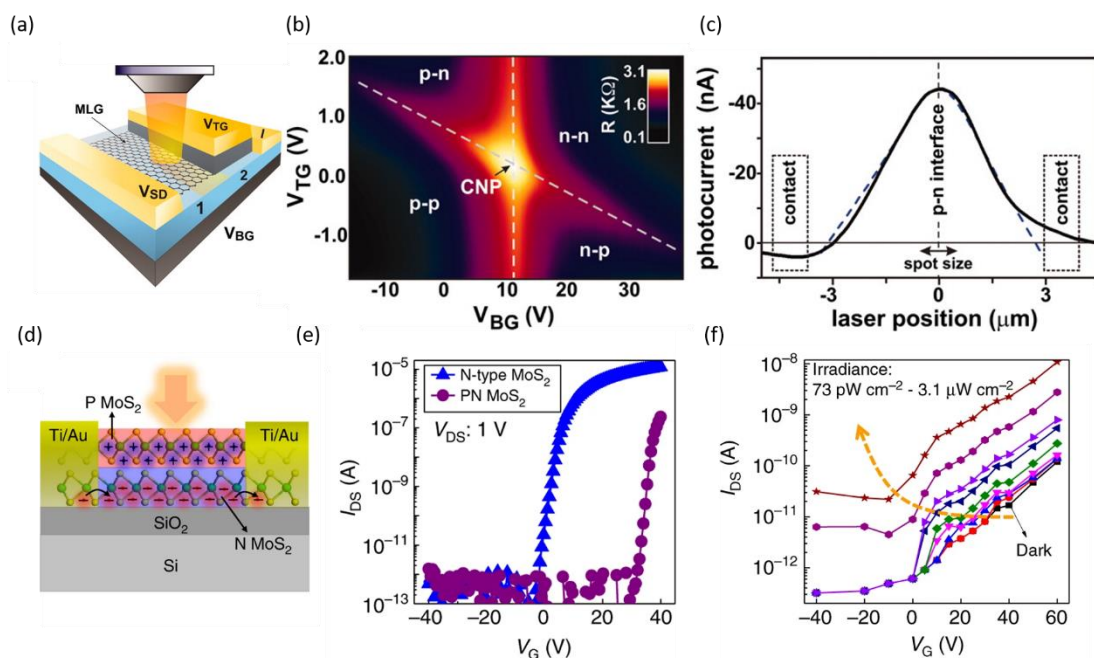
628 be defined as

$$629 \quad G_{ph} = \frac{\tau_{life} \cdot \mu \cdot V_{bias}}{L^2} \quad (13)$$

630 where  $L$  is the channel length,  $\mu$  is the carrier mobility.

### 631 3.3. Photodetectors based on PN junctions

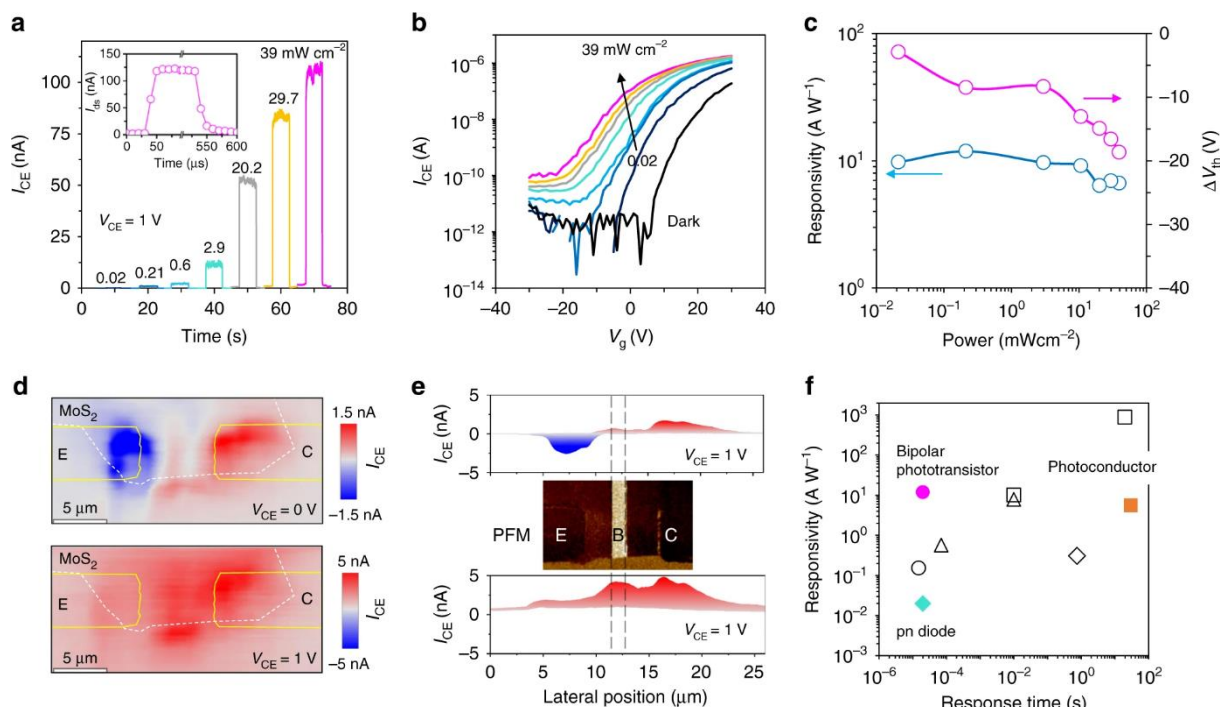
632 For 2D materials, iron-doping and adsorbates of the materials are often applied to achieve p-  
 633 type or n-type semiconductors, as shown in [Figure 22](#). Structure of 2D materials applied in the  
 634 devices are basically categorized into the homojunction and heterojunction. Detectors based  
 635 on various 2D materials has been reported. [132] Graphene PN junction was formed by  
 636 applying voltages with opposite polarities on the top and bottom gate, as shown in [Figure](#)  
 637 [23\(a\)-\(c\)](#). Thermo-induced carriers were considered to play an important role in the  
 638 optoelectronic response of graphene, and the photocurrent was demonstrated to be >40 nA  
 639 with a relatively low voltage bias and an incident light with the wavelength of 850 nm.  
 640 Responsivity was correspondingly measured to be 5 mA W<sup>-1</sup> which was relatively small  
 641 compared with FETs photodetectors, yet larger than the previously reported 1 mA W<sup>-1</sup>. MoS<sub>2</sub>  
 642 homojunction photodetectors with a ultra-high responsivity of 7×10<sup>4</sup> A W<sup>-1</sup> and EQE>10%  
 643 has been reported by Huo *et al.* [133] p-type and n-type MoS<sub>2</sub> was achieved by chemical  
 644 doping and form a vertical junction as



645  
 646 **Figure 23.** (a)-(c) Photodetectors based on graphene homo-junction and the photocurrent with  
 647 incident light. (d) MoS<sub>2</sub> homo-junction photodetector, (e) electrical properties of the devices  
 648 and (f) photocurrent generated with light illumination.

649 shown in [Figure 24\(d\)-\(f\)](#). Moreover, TMDs including WSe<sub>2</sub>, WS<sub>2</sub>, MoTe<sub>2</sub> et al. have been  
 650 utilized in the photodetectors. [134] The photodetectors using 2D materials heterojunctions  
 651 have also been investigated and optimized in many aspects, which are summarized in Ref.  
 652 [135, 134, 136].

653 Lv et al. has also reported on the 2D photodetectors with MoS<sub>2</sub> homo-junction. [122] Doping  
 654 in MoS<sub>2</sub> channel was reconfigurable by ferroelectric polarization. Polarization upward of  
 655 P(VDF-TrFE) with was applied as ferroelectric layer in the experiments due to its remarkable  
 656 coercive field of  $\sim 5 \times 10^7$  V m<sup>-1</sup>. The MoS<sub>2</sub> channel turned into p-type semiconductor with  
 657 upward polarization and reversal of external electric field resulted in switch of majority  
 658 carriers, as n-type doping were enhanced in the MoS<sub>2</sub> channel.  $10^9$ - $10^{13}$  cm<sup>-2</sup> doping in MoS<sub>2</sub>  
 659 was achieved by ferroelectric polarization. It is noticed that voltage applied in polarization  
 660 process varies with different channel materials (eg.  $|V_p| < 10$  V with MoS<sub>2</sub> and  $|V_p| = \pm 6$  V with  
 661 WSe<sub>2</sub>). As shown in [Figure 24](#), responsivity of the photodetector has reached up to  $10^2$ .

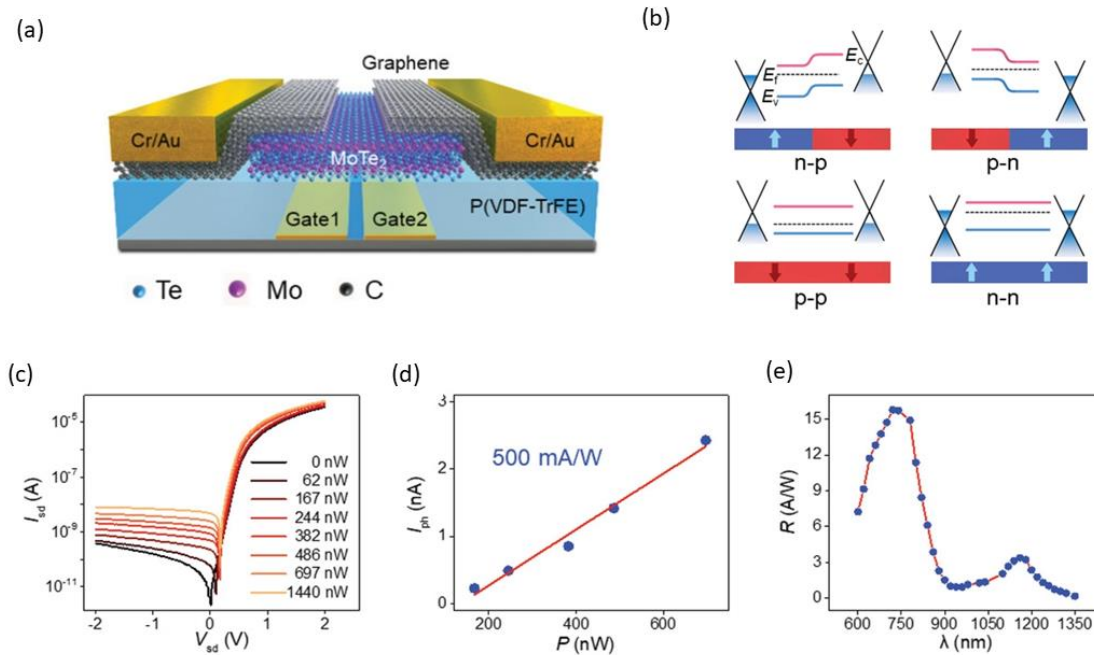


662

663 **Figure 24.** Performance of the MoS<sub>2</sub> homojunction photodetectors.

664 PN junctions based 2D-ferroelectrics hybrid structures are also studied, in which the  
 665 polarization of ferroelectrics could induce carrier transport of 2D materials. Responsivity of  
 666 the device was kept in the magnitude with UV spectrum, which confirmed the function of the  
 667 photodetector at UV region. Moreover, ferroelectrics applied in the photodetector could  
 668 effectively influence the device performance. [137]

669 In addition to the devices based on MoS<sub>2</sub> with ferroelectrics, similar researches have been  
 670 carried out with various materials. Wu et al has reported MoTe<sub>2</sub> PN junction defined by  
 671 ferroelectrics, as shown in [Figure 25](#). [45] PN junction could be converted to n-p, n-n and p-p  
 672 doping by external voltage pulses, as shown in [Figure 25\(b\)](#). Such modified photodetector  
 673 under illumination of different wavelengths including 520 nm and infrared was investigated  
 674 (see [Figure 25\(c\)](#) and Ref [45]). Other figures of merit including EQE and responsivity were  
 675 studied as well and on/off ratio of  $5 \times 10^5$  was achieved. The responsivity could reach  $5 \text{ A W}^{-1}$ ,  
 676 detectivity was  $3 \times 10^{12}$  Jones as well as fast response time of  $30 \mu\text{s}$ . Such PN junctions enable  
 677 photodetection unveiled opportunities for advanced nano photodetectors and realizing next-  
 678 generation optoelectronic devices.

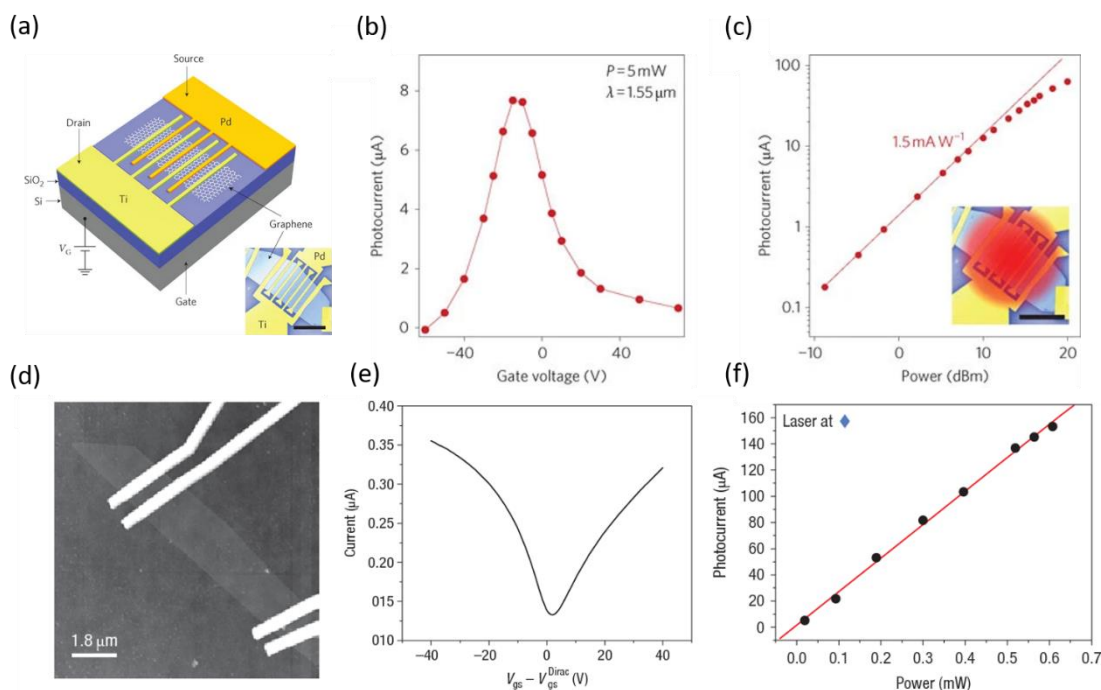


679

680 **Figure 25.** (a) MoTe<sub>2</sub> PN junction controlled by ferroelectric domains. (b) switchable doping  
 681 method defined by polarization. (c)-(e) are devices performances under different illumination.

### 682 3.4. Photodetectors based on field effect transistors

683 Photodetectors based on 2D materials FETs with monolayer graphene as the channel were  
 684 reported in 2008 for the first time. [138] Zero-bandgap graphene has the advantages of wide  
 685 band response, which allows facile generation of photocurrent by the incident light.  
 686 Photocurrent of the graphene photodetector with 514.5 nm incident light reached a maximum  
 687 of ~350 nA with the gate bias varied in a relatively large range (-40 V-40 V), and the  
 688 photocurrent modulation by the gate bias was obviously observed in the devices, as shown in  
 689 [Figure 26\(a\)-\(c\)](#). Suspended graphene monolayer has high Fermi velocity (~1/300 of the  
 690 speed of light in vacuum) and huge electrical mobility (200,000 cm<sup>2</sup>V<sup>-1</sup>s<sup>-1</sup>). Photocurrent of  
 691 the graphene FETs photodetectors has reached over 1 μA and the maximal responsivity was  
 692 0.5 mA W<sup>-1</sup>. [28] For optical communication, the photoresponse in communication band is a  
 693 priority. Graphene has responsivity of 6.1 mA W<sup>-1</sup> at the wavelength of 1550 nm. Back gate  
 694 monolayer graphene photodetectors at a data rate of 10 Gbit s<sup>-1</sup> at 1550 nm incident light was  
 695 achieved, as shown in [Figure 26\(d\)-\(f\)](#).



696

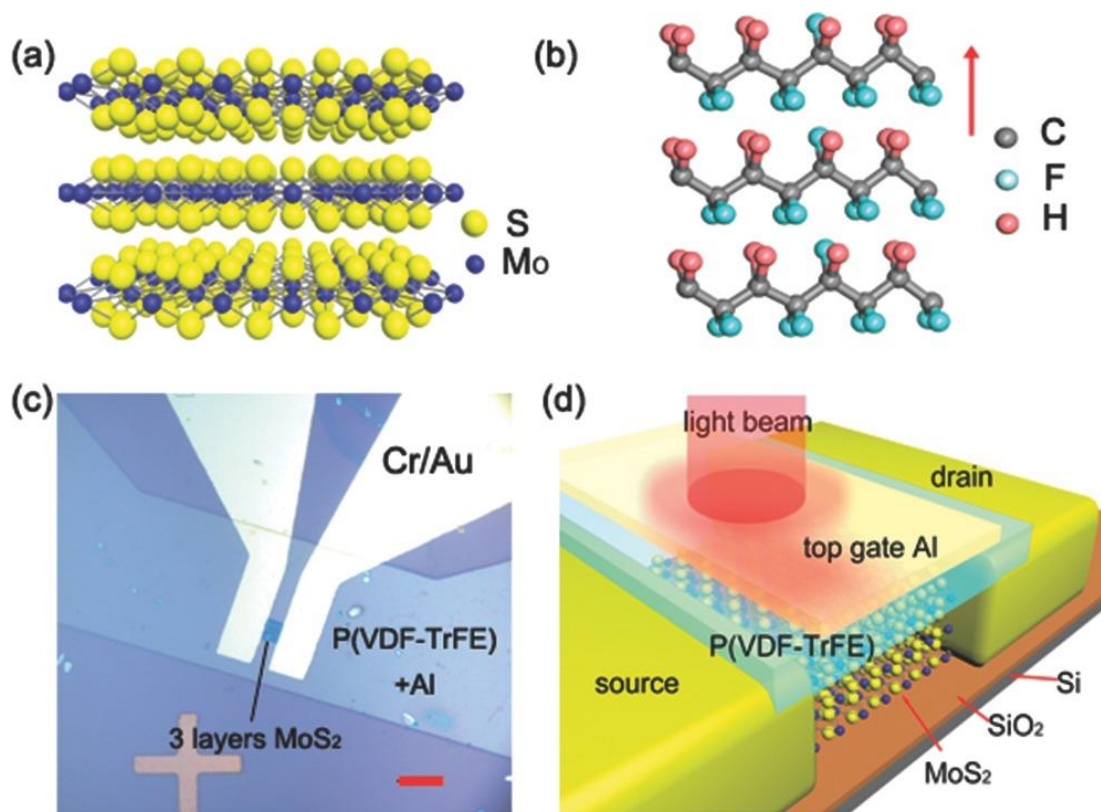
697 **Figure 26.** (a)-(c) is Graphene photodetectors where (a) is the structure of the devices, (b) and  
 698 (c) are the photocurrent dependent on the gate voltage and incident power intensity,  
 699 respectively.[138] (d)-(f) is Back gate monolayer graphene phototransistors enable high speed  
 700 photo communication.[28]

701 Besides graphene other 2D materials, for instance the CNTs, TMDs and h-BN etc. have been  
 702 also applied in photodetection inspired by graphene FETs photodetectors. Similar MoS<sub>2</sub>  
 703 monolayer FET structures and devices have been reported, firstly by Yin et al. in 2011[129]  
 704 One of the most prominent properties of the MoS<sub>2</sub> different from graphene is that monolayer  
 705 MoS<sub>2</sub> has an intrinsic bandgap of 1.8 eV, which enables MoS<sub>2</sub> to be “switched off” in the  
 706 FETs. However, the pristine MoS<sub>2</sub> has relatively low mobility ranging from 0.5 cm<sup>2</sup>V<sup>-1</sup>s<sup>-1</sup> to 3  
 707 cm<sup>2</sup>V<sup>-1</sup>s<sup>-1</sup>, [139] which could result in the impurity scattering and remote charge. High-*k*  
 708 dielectrics could be good in improving the transport properties which could provide charge  
 709 screening and reduce the trap/impurity scattering, then could consequently improve the carrier  
 710 mobility. Inorganic HfO<sub>2</sub> and Al<sub>2</sub>O<sub>3</sub> are among the most studied dielectrics, for the organic  
 711 materials, PVDF is a typical material that was utilized as the gate insulator. The mobility of  
 712 MoS<sub>2</sub> could be increased by two orders of magnitude, together with high on/off ratio of 10<sup>8</sup>

713 and is thus very promising in the device applications [140]. In MoS<sub>2</sub> FET photodetectors,  
714 photocurrent is linearly proportional to the power of incident light High on/off ratio with  $\sim 10^8$   
715 could be achieved by high-k dielectrics like PZT, HfO<sub>2</sub> and Al<sub>2</sub>O<sub>3</sub>. On/off ratio for the simple  
716 back gate monolayer MoS<sub>2</sub> with SiO<sub>2</sub> as gate insulator was measured to be  $10^2$ - $10^3$ , and the  
717 delay was at  $\sim 50$  ms. [129] The back gate monolayer MoS<sub>2</sub> FET was fabricated and the  
718 photoresponsivity was 7.5 mA/W with low power incident light ( $P=80 \mu\text{W}$ ) and medium gate  
719 bias ( $V_g=50$  V) [129].

720 FET Photodetectors based on TMDs, BP and h-BN with remarkable photoresponse has also  
721 been studied and shown. Improvement of the devices performance and novel phenomena were  
722 found and discussed. 2D material heterostructures was achieved to realize the photodetection  
723 [141]. More recently, many studies are devoting themselves to realize flexible and transparent  
724 photodetectors using 2D materials, which are of great interest for the future applications of  
725 wearable and solar-energy devices.

726 Photodetectors based on 2D materials modulated by ferroelectrics has been reported since  
727 2015. Initially ferroelectrics were introduced to 2D FET photodetectors only thanks to their  
728 high-k property, which can be used to enhance the photodetection performance. Wang *et al.*  
729 are among the first groups demonstrating MoS<sub>2</sub> based 2D photodetectors driven by  
730 ferroelectric P(PVDF-TrFE) and they proposed the device structure as shown in in [Figure](#)  
731 [27](#). [142] Few layer MoS<sub>2</sub> was used as semiconducting channel while the P(VDF-TrFE) was  
732 employed as the gate insulator. Dark current with non-polarized P(VDF-TrFE) was measured  
733 at  $10^{-7}$ - $10^{-8}$  A and could be depressed to  $<10^{-10}$  A with polarized-up P(VDF-TrFE). Signal-to-  
734 noise-ratio reached  $10^3$  using polarized gate. Illuminated by an incident light with a  
735 wavelength of 635 nm, the photocurrent of the device reached  $>50 \mu\text{A}$  at a low power of 1nW  
736 and 5 V source-drain voltage. Meanwhile, the stable polarization of P(VDF-TrFE) provided a  
737 high electric field ( $\sim 10^9$  V m<sup>-1</sup> within the nanometer scale) thus keeping the MoS<sub>2</sub> channel in  
738 the fully depleted state, which significantly improved the sensitivity of the detector. The



739

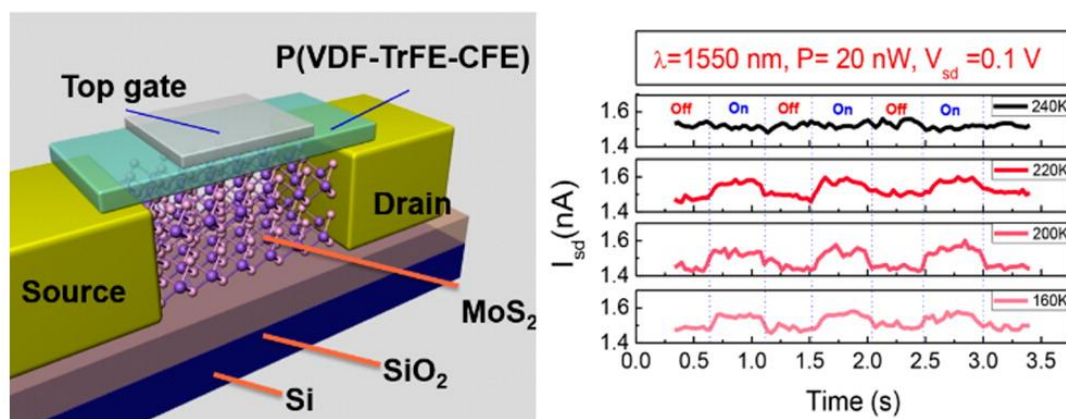
740 **Figure 27.** Ultra-sensitive MoS<sub>2</sub> photodetectors with ferroelectrics

741 photodetector reached quite a high detectivity  $\sim 2.2 \times 10^{12}$  Jones and a responsivity up to 2570  
 742 A W<sup>-1</sup>.

743 Similar 2D-ferroelectrics phototransistors have recently been extensively studied and  
 744 reported. Wide band photodetection (from visible light to 1550 nm) was achieved and the  
 745 relative high sensitivity  $>340$  A W<sup>-1</sup> was measured with an incident light wavelength of  
 746 450nm.[143] Considering that both the crystalline structure of ferroelectric gate materials and  
 747 the carrier transport fluctuation in the 2D materials strongly depend on the temperature  
 748 variation, the temperature dependence of the 2D-ferroelectrics hybrid FET photodetectors  
 749 have been studied. Chen *et al.* has reported that a low temperature of 200 K could transform  
 750 the lattice structure of P(VDF-TrFE-CFE) into ferroelectrics/relaxor, which changes the  
 751 property of P(VDF-TrFE) and could further modulate the band structure of the few-layer



752 MoS<sub>2</sub> material, enabling the long wavelength detection to 1550 nm, as shown in [Figure](#)



753  
754 **Figure 28.** Schematic illustration of the MoS<sub>2</sub> photodetectors driven by ferroelectric gate and  
755 the temperature dependence of the response at 1550 nm incident light.

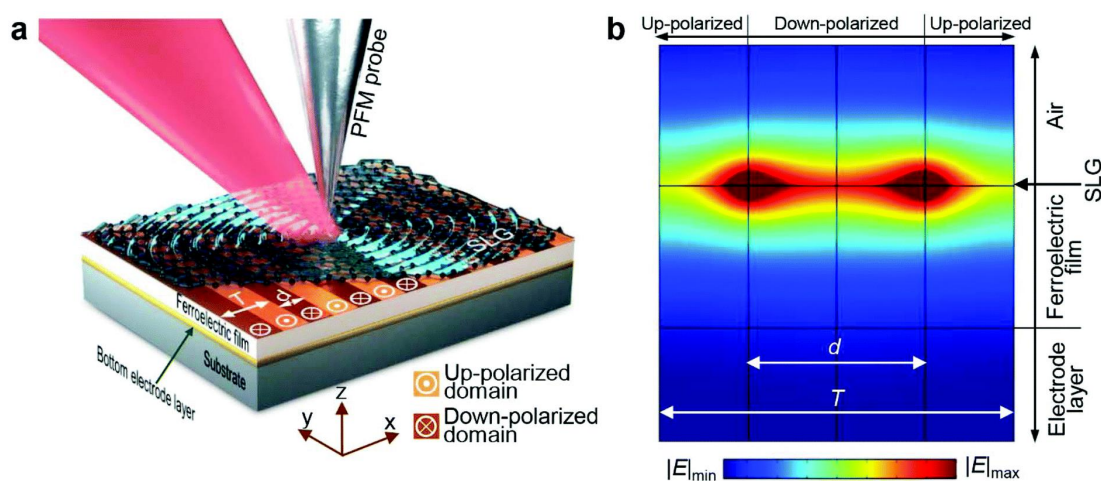
756 [28](#).<sup>[143]</sup> Screening coulomb impurities of ferroelectrics could also enhance the carrier  
757 mobility of MoS<sub>2</sub>.

758 On-off ratio and delay are another two key figures of merits of the 2D-ferroelectrics hybrid  
759 photodetectors. On/off ratio of the devices was determined at zero gate bias at a low drain  
760 currents, while delay time of the devices accounts for the time required to switch the device  
761 on. Both on/off ratio and delay time express the response speed of the devices. On/off ratio  
762 for the monolayer MoS<sub>2</sub> based nano electronic devices could reach up to 10<sup>8</sup> [144] and the  
763 simplest back gate FETs as photodetectors have an on/off ratio of 10<sup>2</sup>-10<sup>3</sup> [145]. Application  
764 of the ferroelectrics has been proved to be able to significantly improve the sensitivity, the  
765 on/off ratio and the SNR of photodetector. On/off ratio of MoS<sub>2</sub> photodetector with P(VDF-  
766 TrFE) applied as ferroelectric gate was increased to >10<sup>4</sup> with dark current approximately to  
767 10<sup>-11</sup> A [146].

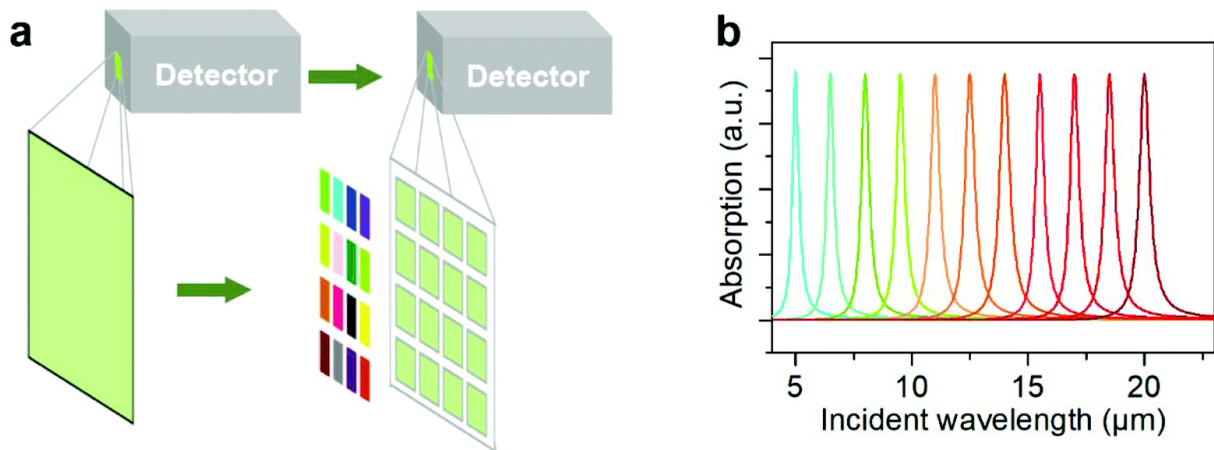
768 In the 2D-ferroelectrics hybrid photodetectors, some unique properties of 2D materials, like  
769 the plasmonic behaviors of graphene, could be modulated by the ferroelectrics, which further  
770 improve the photodetection performances. An ultra-high responsivity up to 7.62×10<sup>6</sup> A W<sup>-1</sup>  
771 has been reported graphene-ferroelectrics photodetectors, which is much beyond the

772 previously reported experimental results. Meanwhile, detectivity reached  $\sim 6.24 \times 10^7$  Jones  
 773 with infra-red band photodetection. [147] Graphene was transferred on the pre-polarized  
 774 ferroelectric substrate and the graphene plasmons was excited by the polarized domains.  
 775 Graphene plasmons resonates at the boundaries, as shown in [Figure 29](#). Polarized domains at  
 776 the substrate could modulate the carrier density and the chemical potential (namely the Fermi  
 777 level) of graphene by the external electric field. Broad band photodetector with wavelengths  
 778 ranging from  $5\mu\text{m}$  to  $20\mu\text{m}$  was achieved, as shown in [Figure 30](#).

779 For the extensive investigation of 2D materials and ferroelectrics. There is a group of unique  
 780 2D semiconductors, represented by  $\alpha\text{-In}_2\text{Se}_3$ , shares both semiconductor property and the  
 781 ferroelectricity. The combined properties make it potential in the ultra-thin photodetectors due  
 782 to its capability of playing a dual role in the application of photodetectors. Hou et al has  
 783 reported the  $\alpha\text{-In}_2\text{Se}_3$  applied in the photodetectors, as shown in [Figure 31](#). [148] Polarization  
 784 of  $\alpha\text{-In}_2\text{Se}_3$  pull the electrons to the surface of the materials and consequently forms into an  
 785 electric field, which would influence the electrical properties of the photodetectors. On/off  
 786 ratio of the photodetector was measured to be  $2 \times 10^7$  and the comparison of the photodetector  
 787 with and without polarization demonstrated that the polarization could prolong the decay yet  
 788 significantly improve the on/off ratio with even three orders of magnitude, and



789  
 790 **Figure 29.** pre-polarized graphene photodetector and the plasmons excited by the polarized-  
 791 up and -down domains



792

793 **Figure 30.** Graphene plasmonic photodetector controlled by ferroelectric domains and the  
794 wide-band response

795 Photodetectors with Pt electrodes could further optimize the on/off ratio by four orders of  
796 magnitude.

797 In addition to traditional ferroelectrics, recent emerged ferroelectric semiconductors have also  
798 attracted many interests and have been applied into 2D-ferroelectris hybrid photodetectors.

799 The ferroelectric TMD  $\alpha$ -indium selenide ( $\text{In}_2\text{Se}_3$ ) is one typical representative.

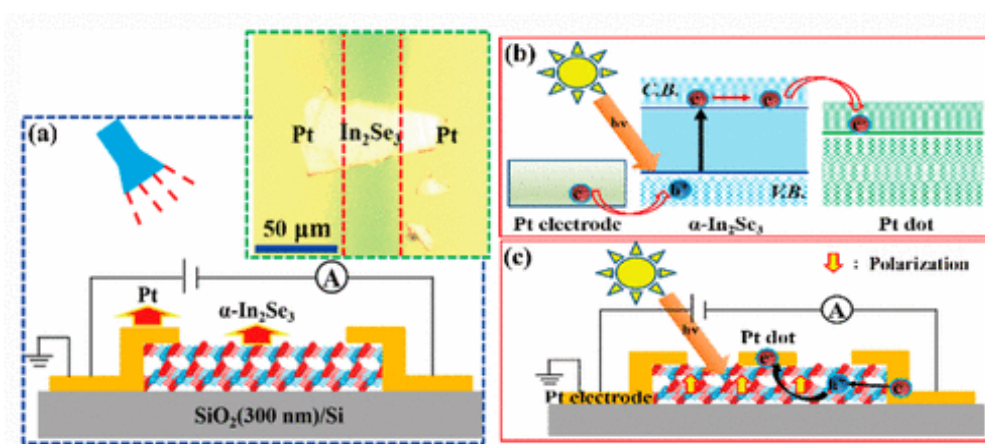
800 Photodetectors based on  $\text{WSe}_2$  and  $\alpha$ -  $\text{In}_2\text{Se}_3$  heterostructures have been reported in 2020.

801 [149] and ultra-low dark current of  $10^{-13}$  A was achieved, which is a remarkable result

802 compared to photodetectors with the similar structure. Meanwhile, such device also has high

803 on/off ratio exceeding  $1.24 \times 10^5$  and photoresponse of  $26 \text{ mA W}^{-1}$ . Liu *et al.* has also reported

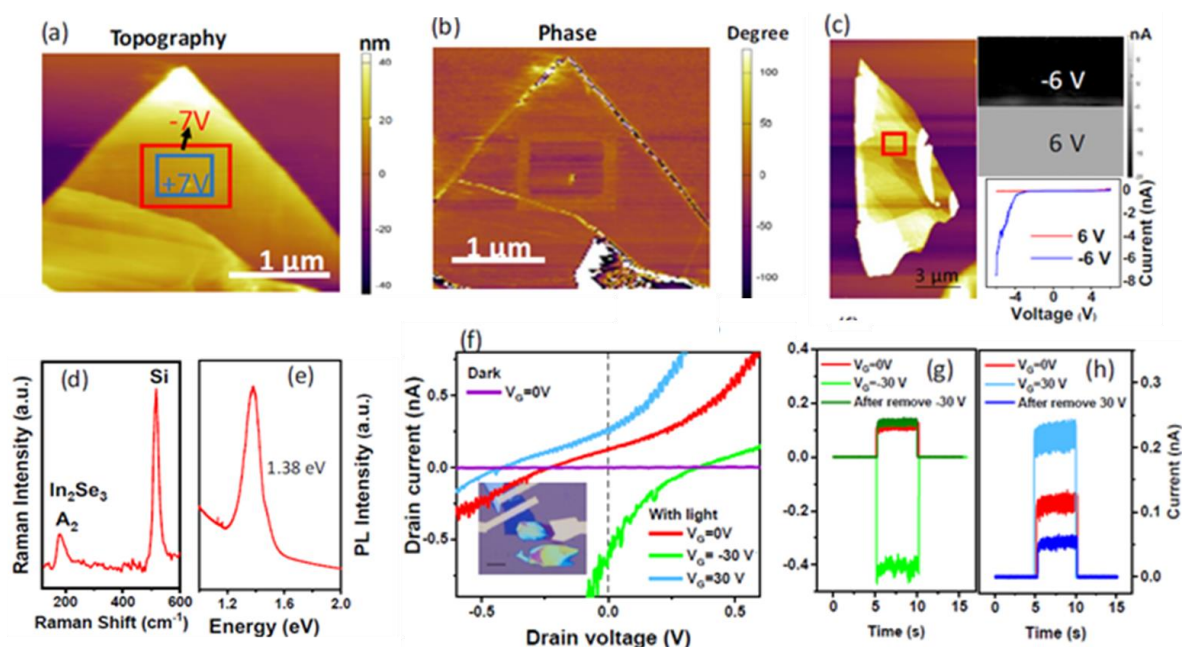
804  $\text{InSe}_2$  photodetectors with P(VDF-TrFE) ferroelectric gate. [120] Different polarization of



805

806 **Figure 31.** Schematics of the  $\alpha$ - $\text{In}_2\text{Se}_3$  photodetector.

807 P(VDF-TrFE) was studied to improve the performance of the photodetector. High on/off ratio  
 808 of  $10^8$ , fast response time of  $600 \mu\text{s}$  and high photoresponsivity up to  $14250 \text{ AW}^{-1}$  were  
 809 achieved. However, few researches were focused on the ferroelectricity of InSe materials. Xu  
 810 et al. as briefly reported the optoelectronic properties in  $\text{WSe}_2/\text{In}_2\text{Se}_3$  heterostructures in 2018,  
 811  $\text{In}_2\text{Se}_3$  was polarized and the output properties in dark and under illumination was investigated,  
 812 as shown in [Figure 32](#). Photocurrent was enhanced with positive voltage bias applied in gate  
 813 dielectrics. Enhancement and weaken of the photocurrent were able to be modulated by  
 814 varying the voltage bias from negative to positive, as shown in [Figure 32\(f\)](#). Photoresponse  
 815 was thus improved by ferroelectric modulation.



816  
 817 **Figure 32.** (a) Height image and (b) out-of-plane phase image of  $\text{In}_2\text{Se}_3$  in PFM measurement.  
 818 (c) Topography image, current mapping and local IV curves after writing with  $-6 \text{ V}$  and  $6 \text{ V}$   
 819 in CAFM measurement. (d) Raman spectrum and (e) PL spectrum of a  $\alpha\text{-In}_2\text{Se}_3$  flake. (f)  
 820 Photocurrent as a function of drain voltage of the photodetector based on  $\text{WSe}_2/\text{In}_2\text{Se}_3$   
 821 heterostructure measured at various gate voltages. Inset: optical image of the device. (g) and  
 822 (h) Short-circuit current as a function of time measured in a photodetector based on the  
 823  $\text{WSe}_2/\text{In}_2\text{Se}_3$  heterostructure before, during, and after applied  $+30 \text{ V}$  and  $-30 \text{ V}$  gate voltages.

**824 4. Conclusions and perspectives**

825 In this review, we have reviewed the fundamentals of two-dimensional semiconductors and  
826 ferroelectrics as well as their application in photodetection. Hybrid system of two-  
827 dimensional materials and ferroelectrics could interact with each other, and thus realize higher  
828 performances and enable modulation of the devices. This novel combination structure has  
829 provided new methods for multiple functional nano-devices and compatible circuits.

830 In materials aspect, structure, physical properties, electrical properties as well as  
831 optoelectronic properties has been reviewed. Additionally, interaction between two-  
832 dimensional materials and ferroelectrics has been introduced.

833 In devices aspect, photodetectors based on two-dimensional materials and ferroelectrics has  
834 been categorized based on their structures and the performances as well as the interaction in  
835 the hybrid system has been reviewed. Researches based on two-dimensional materials and  
836 ferroelectrics have shown great potential in photodetectors. Remarkable achievements have  
837 witnessed however, problems still exist. Considering the structure of the devices, most of the  
838 researches focused on the field effect transistors with ferroelectrics as top gate, more work  
839 still remains to be done in the study of the ferroelectric layer applied as bottom gate as well as  
840 substrates. Meanwhile, photodetectors based on PN junctions are mostly based on the vertical  
841 heterojunctions with silicon as substrate or doped lateral junctions. Modulation of the carrier  
842 type and the junction generated from ferroelectric polarization has not been fully investigated  
843 either. Details and the mechanism of interaction between the two-dimensional semiconductor  
844 and the functional ferroelectric layer is still unintelligible, which is currently a challenge for  
845 the application of photodetectors based on 2D materials and ferroelectrics. As is mentioned  
846 before that the 2D materials has outstanding flexibility and mechanical strength, the joint  
847 ferroelectric substrates in the flexible devices are expecting to be flexible and transparent as  
848 well. Therefore, more attention is required on designing and fabrication of ultrathin  
849 ferroelectric film with high transparency and outstanding mechanical properties.

850 In conclusion, photodetectors based on two dimensional materials, ferroelectrics as well as the  
851 hybrid structures is promising structure for wide band high performance photodetection.  
852 Ferroelectric provide effective modulation of the devices and thus improve optical and  
853 optoelectronic properties of the devices. It is promising that the ferroelectric layer being  
854 applied as component of integrated circuit and will certainly lead to another prosperity area in  
855 exploring the road "More than Moore".

856

### 857 **Acknowledgements**

858 We acknowledge the funding support from Key R&D Program of Shaanxi Province of China  
859 (2020GY-271 and 2018ZDXM-GY-150), the Fundamental Research Funds for the Central  
860 Universities(xjj2018016), the "111 Project" of China (B14040), the Open Project of State Key  
861 Laboratory of Infrared Technological Physic (Grant No. M201801), the Open Project of State  
862 Key Laboratory of Electronic Thin Films and Integrated Devices (KFJJ201902) and the  
863 Natural Sciences and Engineering Research Council of Canada (NSERC DG Grant No.  
864 203773).

865

866 Received: ((will be filled in by the editorial staff))

867 Revised: ((will be filled in by the editorial staff))

868 Published online: ((will be filled in by the editorial staff))

869

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